# MOS INTEGRATED CIRCUIT $\mu$ PD75P3116

# **4-BIT SINGLE-CHIP MICROCONTROLLER**

The  $\mu$ PD75P3116 replaces the  $\mu$ PD753108's internal mask ROM with a one-time PROM, and features expanded ROM capacity.

Because the  $\mu$ PD75P3116 supports programming by users, it is suitable for use in evaluation of systems in the development stage using the  $\mu$ PD753104, 753106, or 753108, and for use in small-scale production.

Detailed information about functions is provided in the following User's Manual. Be sure to read it before designing:

 $\mu$ PD753108 User's Manual: U10890E

#### FEATURES

NEC

- $\bigcirc$  Compatible with  $\mu$ PD753108
- Memory capacity:
  - PROM: 16384  $\times$  8 bits
  - RAM:  $512 \times 4$  bits
- $\bigcirc$  Can be operated in same power supply voltage range as the mask version  $\mu$ PD753108
  - VDD = 1.8 to 5.5 V
- On-chip LCD controller/driver
- QTOP<sup>™</sup> microcontroller

**Remark** QTOP microcontrollers are microcontrollers with on-chip one-time PROM that are totally supported by NEC. This support includes writing application programs, marking, screening, and verification.

# **ORDERING INFORMATION**

Part Number	Package
μPD75P3116GC-AB8	64-pin plastic QFP ( $14 \times 14$ )
μPD75P3116GK-8A8	64-pin plastic LQFP (12 $ imes$ 12)
$\mu$ PD75P3116GC-8BS	64-pin plastic LQFP (14 $ imes$ 14)

Caution This device does not provide an internal pull-up resistor connection function by means of mask option.

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version. Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

# FUNCTION OUTLINE

ltem			Function		
Instruction execution time		• 0.67	<ul> <li>0.95, 1.91, 3.81, or 15.3 μs (main system clock: @ 4.19 MHz)</li> <li>0.67, 1.33, 2.67, or 10.7 μs (main system clock: @ 6.0 MHz)</li> <li>122 μs (subsystem clock: @ 32.768 kHz)</li> </ul>		
Internal memory	PROM	16384	×8 bits		
	RAM	512 ×	4 bits		
General-purpose	registers		manipulation: 8 × 4 banks manipulation: 4 × 4 banks		
I/O ports	CMOS input	8	Internal pull-up resistor connection can be specified by software setting:		
	CMOS I/O	20	Internal pull-up resistor connection can be specified by software setting: 12 Shared with segment pins: 8		
	N-ch open-drain I/O	4	13 V withstanding voltage		
	Total	32			
LCD controller/driver		_	nent number selection: 16/20/24 segments (switchable to CMOS I/O ports in a batch of 4 pins, max. 8 pins) lay mode selection: Static, 1/2 duty (1/2 bias), 1/3 duty (1/2 bias), 1/3 duty (1/3 bias), 1/4 duty (1/3 bias)		
Timers		5 char	<ul> <li>5 channels: • 8-bit timer/event counter: 3 channels <ul> <li>(Can be used as 16-bit timer/event counter, carrier generator, and timer with gate)</li> <li>• Basic interval timer/watchdog timer: 1 channel</li> <li>• Watch timer: 1 channel</li> </ul> </li> </ul>		
Serial interface		• 2-wir	<ul> <li>3-wire serial I/O mode MSB/LSB first switchable</li> <li>2-wire serial I/O mode</li> <li>SBI mode</li> </ul>		
Bit sequential buff	er (BSB)	16 bits	16 bits		
Clock output (PCL	-)		$\Phi$ , 524, 262, and 65.5 kHz (main system clock: @ 4.19 MHz) $\Phi$ , 750, 375, and 93.8 kHz (main system clock: @ 6.0 MHz)		
Buzzer output (BL	JZ)		• 2, 4, and 32 kHz (main system clock: @ 4.19 MHz or subsystem clock: @ 32.768 kHz • 2.93, 5.86, 46.9 kHz (main system clock: @ 6.0 MHz)		
Vectored interrupts			• External: 3 • Internal: 5		
Test inputs			• External: 1 • Internal: 1		
System clock oscillator			Ceramic/crystal oscillator for main system clock     Crystal oscillator for subsystem clock		
Standby function		STOP	STOP/HALT mode		
Power supply volt	age	Vdd =	1.8 to 5.5 V		
Package		• 64-p	<ul> <li>64-pin plastic QFP (14 × 14)</li> <li>64-pin plastic LQFP (12 × 12)</li> <li>64-pin plastic LQFP (14 × 14)</li> </ul>		

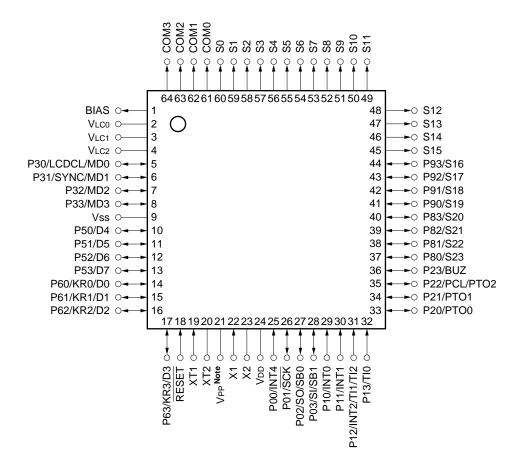
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## 1. PIN CONFIGURATION (TOP VIEW)

- 64-pin plastic QFP (14  $\times$  14):  $\mu$ PD75P3116GC-AB8
- 64-pin plastic LQFP (12 × 12): μPD75P3116GK-8A8
- 64-pin plastic LQFP (14 × 14): μPD75P3116GC-8BS

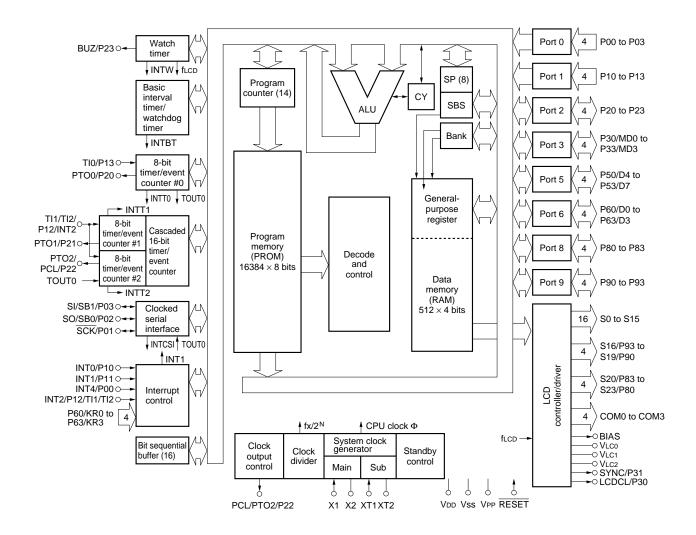


Note Always connect the VPP pin directly to VDD during normal operation.

# **PIN IDENTIFICATIONS**

P00 to P03:	Port 0	COM0 to COM3:	Common output 0 to 3
			•
P10 to P13:	Port 1	VLC0 to VLC2:	LCD power supply 0 to 2
P20 to P23:	Port 2	BIAS:	LCD power supply bias control
P30 to P33:	Port 3	LCDCL:	LCD clock
P50 to P53:	Port 5	SYNC:	LCD synchronization
P60 to P63:	Port 6	TI0 to TI2:	Timer input 0 to 2
P80 to P83:	Port 8	PTO0 to PTO2:	Programmable timer output 0 to 2
P90 to P93:	Port 9	BUZ:	Buzzer clock
KR0 to KR3:	Key return 0 to 3	PCL:	Programmable clock
SCK:	Serial clock	INT0, 1, 4:	External vectored interrupt 0, 1, 4
SI:	Serial input	INT2:	External test input 2
SO:	Serial output	X1, X2:	Main system clock oscillation 1, 2
SB0, SB1:	Serial data bus 0, 1	XT1, XT2:	Subsystem clock oscillation 1, 2
RESET:	Reset	VPP:	Programming power supply
MD0 to MD3:	Mode selection 0 to 3	Vdd:	Positive power supply
D0 to D7:	Data bus 0 to 7	Vss:	Ground
S0 to S23:	Segment output 0 to 23		

# 2. BLOCK DIAGRAM



# 3. PIN FUNCTIONS

# 3.1 Port Pins (1/2)

*	

Pin Name	I/O	Alternate Function	Function	8-Bit I/O	Status After Reset	I/O Circuit Type <sup>Note 1</sup>
P00	Input	INT4	4-bit input port (Port 0)	_	Input	<b></b>
P01		SCK	Connection of an internal pull-up resistor can be specified by a software setting in 3-bit units.			<f>-A</f>
P02		SO/SB0				<f>-B</f>
P03		SI/SB1	_			<m>-C</m>
P10	Input	INT0	4-bit input port (Port 1)	_	Input	<b>-C</b>
P11		INT1	Connection of an internal pull-up resistor can be specified by a software setting in 4-bit units.			
P12		TI1/TI2/INT2	P10/INT0 can be used to select a noise eliminator.			
P13		TIO				
P20	I/O	PTO0	4-bit I/O port (Port 2) Connection of an internal pull-up resistor can be specified by a software setting in 4-bit units.	_	Input	E-B
P21		PTO1				
P22		PCL/PTO2				
P23		BUZ				
P30	I/O	LCDCL/MD0	Programmable 4-bit I/O port (Port 3) Input and output can be specified in 1-bit units. Connection of an internal pull-up resistor can be	_	Input	E-B
P31		SYNC/MD1				
P32		MD2	specified by a software setting in 4-bit units.			
P33		MD3	-			
P50 <sup>Note 2</sup>	I/O	D4	N-ch open-drain 4-bit I/O port (Port 5) When set to open-drain, the withstanding voltage is 13 V.	_	High	M-E
P51 <sup>Note 2</sup>	1	D5			impedance	
P52 <sup>Note 2</sup>	1	D6	1			
P53 <sup>Note 2</sup>		D7				

Notes 1. Circuit types enclosed in angle brackets indicate Schmitt-triggered input.

2. The low-level input leakage current increases when input instructions or bit manipulation instructions are executed.

# 3.1 Port Pins (2/2)

Pin Name	I/O	Alternate Function	Function	8-Bit I/O	Status After Reset	I/O Circuit Type <sup>Note 1</sup>
P60	I/O	KR0/D0	Programmable 4-bit I/O port (Port 6)	_	Input	<f>-A</f>
P61		KR1/D1	Input and output can be specified in 1-bit units. Connection of an internal pull-up resistor can be			
P62		KR2/D2	specified by a software setting in 4-bit units.			
P63		KR3/D3				
P80	I/O	S23	4-bit I/O port (Port 8)	$\checkmark$	Input	Н
P81		S22	Connection of an internal pull-up resistor can be specified by a software setting in 4-bit units <sup>Note 2</sup> .			
P82		S21				
P83		S20				
P90	I/O	S19	Programmable 4-bit I/O port (Port 9)		Input	Н
P91		S18	Connection of an internal pull-up resistor can be specified by a software setting in 4-bit units <sup>Note 2</sup> .			
P92		S17				
P93		S16				

Notes 1. Circuit types enclosed in angle brackets indicate Schmitt-triggered input.

2. Do not connect an internal pull-up resistor by software when these pins are used as segment signal outputs.

# 3.2 Non-Port Pins (1/2)

Pin Name	I/O	Alternate Function	Function		Status After Reset	I/O Circuit Type <sup>Note 1</sup>
TIO	Input	P13	External event pulse input to timer/event counter		Input	<b>-C</b>
TI1		P12/INT2/TI2				
TI2		P12/INT2/TI1				
PTO0	Output	P20	Timer/event counter output		Input	E-B
PTO1		P21				
PTO2		P22/PCL				
PCL		P22/PTO2	Clock output			
BUZ		P23	Frequency output (for buzzer or syste	em clock trimming)		
SCK	I/O	P01	Serial clock I/O		Input	<f>-A</f>
SO/SB0		P02	Serial data output Serial data bus I/O			<f>-B</f>
SI/SB1		P03	Serial data input Serial data bus I/O			<m>-C</m>
INT4	Input	P00	Edge detection vectored interrupt input (valid for detecting both rising and falling edges)			<b></b>
INT0	Input	P10	Edge detection vectored interrupt input (detection edge is selectable) INT0/P10 can be used to select a	With noise eliminator/ asynchronous is selectable	Input	<b>-C</b>
INT1		P11	noise eliminator.	Asynchronous	-	
INT2	Input	P12/TI1/TI2	Rising edge detection testable input	Asynchronous		
KR0 to KR3	I/O	P60 to P63	Parallel falling edge detection testabl	e input	Input	<f>-A</f>
X1	Input		Ceramic/crystal resonator connection		_	_
X2	_		clock oscillation. If using an external to X1 and input the inverted signal to			
XT1	Input	—	Crystal resonator connection for subs If using an external clock, input the si		-	_
XT2	-		the inverted signal to XT2. XT1 can input.			
RESET	Input	—	System reset input (low-level active)		_	<b></b>
MD0 to MD3	Input	P30 to P33	Mode selection for program memory	(PROM) write/verify	Input	E-B
D0 to D3	I/O	P60/KR0 to P63/KR3	Data bus for program memory (PROM) write/verify		Input	<f>-A</f>
D4 to D7		P50 to P53				M-E
VppNote 2	_	_	Programmable power supply voltage applied for program memory (PROM) write/verify. During normal operation, connect directly to VDD. Apply +12.5 V for PROM write/verify.		_	_
Vdd	_		Positive power supply		_	
Vss	_		Ground potential		_	

Notes 1. Circuit types enclosed in angle brackets indicate Schmitt-triggered input.

2. The VPP pin does not operate correctly when it is not connected to the VDD pin during normal operation.

## 3.2 Non-Port Pins (2/2)

Pin Name	I/O	Alternate Function	Function	Status After Reset	I/O Circuit Type
S0 to S15	Output	—	Segment signal output	Note 1	G-A
S16 to S19	Output	P93 to P90	Segment signal output	Input	Н
S20 to S23	Output	P83 to P80	Segment signal output	Input	н
COM0 to COM3	Output	—	Common signal output	Note 1	G-B
VLC0 to VLC2	—	—	Power supply for driving LCD	_	_
BIAS	Output	—	Output for external split resistor cut	Note 2	_
LCDCL <sup>Note 3</sup>	Output	P30/MD0	Clock output for driving external expansion driver	Input	E-B
SYNC <sup>Note 3</sup>	Output	P31/MD1	Clock output for synchronization of external expansion driver	Input	E-B

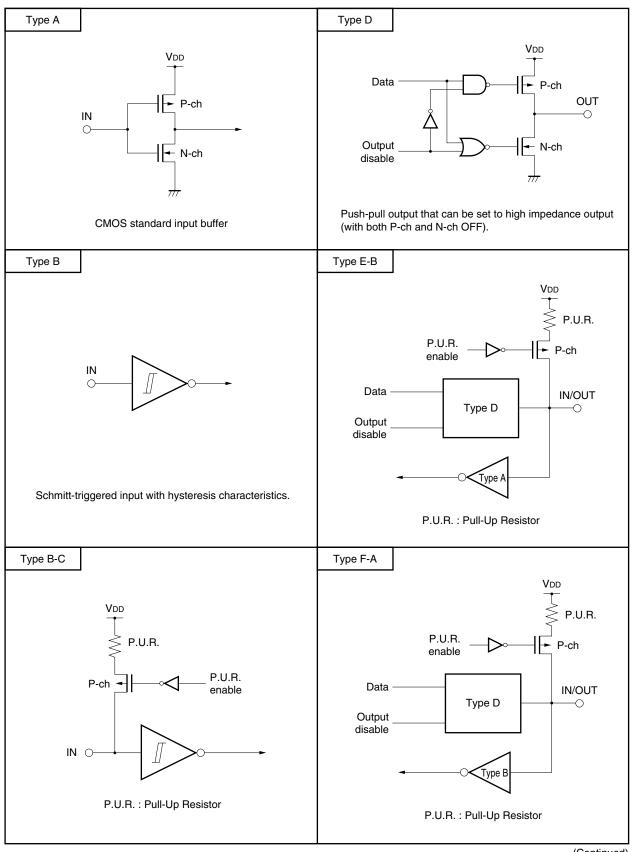
**Notes 1.**  $V_{LCX}$  (X = 0, 1, 2) is selected as the input source for the display outputs as shown below. S0 to S23:  $V_{LC1}$ , COM0 to COM2:  $V_{LC2}$ , COM3:  $V_{LC0}$ 

2. When the split resistor is incorporated: Low level When the split resistor is not incorporated: High impedance

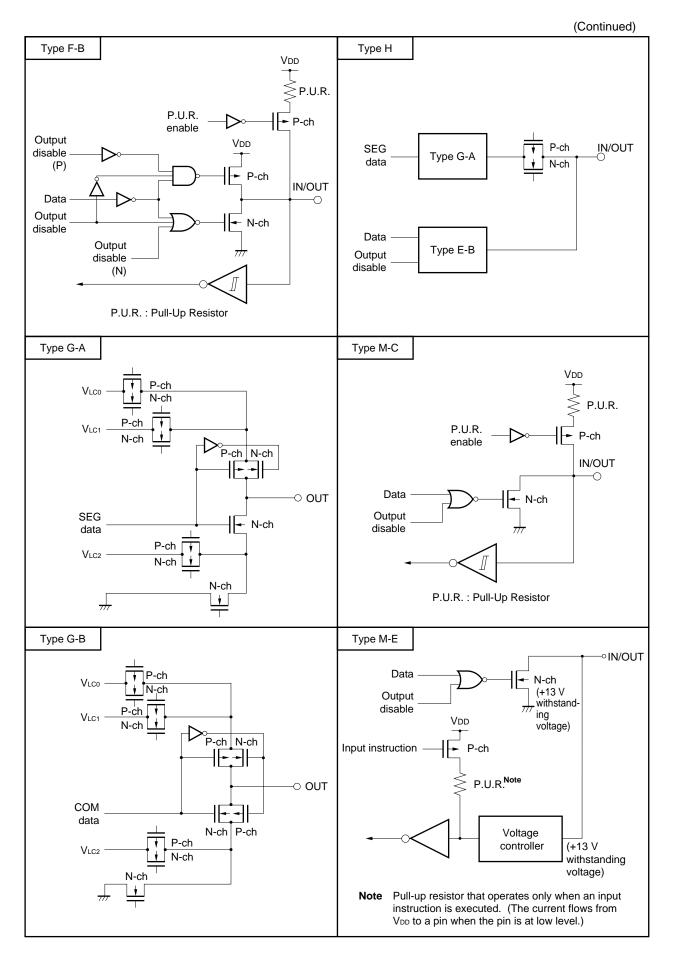
3. These pins are provided for future system expansion. Currently, only P30 and P31 are used.

#### 3.3 Pin I/O Circuits

The I/O circuits for the  $\mu$ PD75P3116's pins are shown in abbreviated form below.



(Continued)



#### 3.4 Recommended Connection of Unused Pins

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Table 3-1.	List of Unused Pin Connections

Pin	Recommended Connection
P00/INT4	Connect to Vss or VDD.
P01/SCK	Input: Independently connect to Vss or VDD via a resistor.
P02/SO/SB0	Output: Leave open.
P03/SI/SB1	Connect to Vss.
P10/INT0 and P11/INT1	Connect to Vss or VDD.
P12/TI1/TI2/INT2	
P13/TI0	
P20/PTO0	Input: Independently connect to Vss or VDD via a resistor.
P21/PTO1	Output: Leave open.
P22/PTO2/PCL	
P23/BUZ	
P30/LCDCL/MD0	
P31/SYNC/MD1	
P32/MD2	
P33/MD3	
P50/D4 to P53/D7	Input: Connect to Vss. Output: Connect to Vss.
P60/KR0/D0 to P63/KR3/D3	Input: Independently connect to Vss or VDD via a resistor. Output: Leave open.
S0 to S15	Leave open.
COM0 to COM3	
S16/P93 to S19/P90	Input: Independently connect to Vss or VDD via a resistor.
S20/P83 to S23/P80	Output: Leave open.
VLC0 to VLC2	Connect to Vss.
BIAS	Connect to Vss only when none of VLC0, VLC1 or VLC2 is used. In other cases, leave open.
XT1 <sup>Note</sup>	Connect to Vss.
XT2 <sup>Note</sup>	Leave open.
Vpp	Always connect to VDD directly.

**Note** When the subsystem clock is not used, select SOS.0 = 1 (on-chip feedback resistor not used).

# 4. Mk I AND Mk II MODE SELECTION FUNCTION

Setting the stack bank selection (SBS) register for the  $\mu$ PD75P3116 enables the program memory to be switched between the Mk I mode and Mk II mode. This function is applicable when using the  $\mu$ PD75P3116 to evaluate the  $\mu$ PD753104, 753106, or 753108.

When bit 3 of SBS is set to 1: Sets the Mk I mode (supports the Mk I mode for the  $\mu$ PD753104, 753106, and 753108) When bit 3 of SBS is set to 0: Sets the Mk II mode (supports the Mk II mode for the  $\mu$ PD753104, 753106, and 753108)

#### 4.1 Differences Between Mk I Mode and Mk II Mode

Table 4-1 lists the differences between the Mk I mode and the Mk II mode for the  $\mu$ PD75P3116.

	Item	Mk I Mode	Mk II Mode					
Program count	er	PC13-0						
Program memo	ory (bytes)	16384						
Data memory (	bits)	512×4	512×4					
Stack	Stack bank	Selectable via memory banks 0 and 1						
No. of stack bytes		2 bytes	3 bytes					
Instruction	BRA laddr1 instruction	Not available	Available					
	CALLA !addr1 instruction							
Instruction	CALL laddr instruction	3 machine cycles	4 machine cycles					
execution time	CALLF !faddr instruction	2 machine cycles	3 machine cycles					
Supported mask ROM products		When set to Mk I mode: μPD753104, 753106, and 753108	When set to Mk II mode: μPD753104, 753106, and 753108					

 Table 4-1. Differences Between Mk I Mode and Mk II Mode

Caution The Mk II mode supports a program area exceeding 16 KB for the 75X and 75XL Series. Therefore, this mode is effective for enhancing software compatibility with products that have a program area of more than 16 KB.

With regard to the number of stack bytes during execution of subroutine call instructions, the usable area increases by 1 byte per stack compared to the Mk I mode when the Mk II mode is selected.

However, when the CALL !addr and CALLF !faddr instructions are used, the machine cycle becomes longer by 1 machine cycle. Therefore, if more emphasis is placed on RAM use efficiency and processing performance than on software compatibility, the Mk I mode should be used.

#### 4.2 Setting of Stack Bank Selection (SBS) Register

Use the stack bank selection register to switch between the Mk I mode and Mk II mode. Figure 4-1 shows the format of the stack bank selection register.

The stack bank selection register is set using a 4-bit memory manipulation instruction. When using the Mk I mode, be sure to initialize the stack bank selection register to  $100 \times B^{Note}$  at the beginning of the program. When using the Mk II mode, be sure to initialize it to  $000 \times B^{Note}$ .

**Note** Set the desired value for  $\times$ .

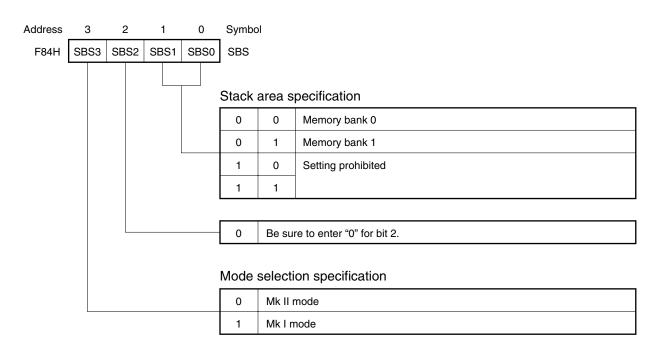


Figure 4-1. Format of Stack Bank Selection Register

Caution SBS3 is set to 1 after RESET input, and consequently the CPU operates in the Mk I mode. When using instructions for the Mk II mode, set SBS3 to 0 and set the Mk II mode before using the instructions.

## 5. DIFFERENCES BETWEEN $\mu \text{PD75P3116}$ AND $\mu \text{PD753104},$ 753106, 753108

The  $\mu$ PD75P3116 replaces the internal mask ROM in the  $\mu$ PD753104, 753106, and 753108 with a one-time PROM and features expanded ROM capacity. The  $\mu$ PD75P3116's Mk I mode supports the Mk I mode in the  $\mu$ PD753104, 753106, and 753108 and the  $\mu$ PD75P3116's Mk II mode supports the Mk II mode in the  $\mu$ PD753104, 753106, and 753108.

Table 5-1 lists differences between the  $\mu$ PD75P3116 and the  $\mu$ PD753104, 753106, and 753108. Be sure to check the differences between these products before using them with PROMs for debugging or prototype testing of application systems or, later, when using them with a mask ROM for full-scale production.

For details of the CPU functions and internal hardware, refer to the User's Manual.

	Item	μPD753104	μPD753106	μPD753108	μPD75P3116		
Program counter		12 bits	its 13 bits		14 bits		
Program memory	(bytes)	Mask ROM 4096	Mask ROM 6144	Mask ROM 8192	One-time PROM 16384		
Data memory (× 4	bits)	512					
Mask options	Pull-up resistor for Port 5	Available (On chip/not on chip	can be specified.)		Not available (Not on chip)		
	Split resistor for LCD driving power supply						
	Wait time after RESET	Available (Selectable between	Not available (Fixed to 2 <sup>15</sup> /fx) <sup>Note</sup>				
	Feedback resistor of subsystem clock	Available (Use/not use can be	Not available (Enable)				
Pin configuration	Pins 5 to 8	P30 to P33			P30/MD0 to P33/MD3		
	Pins 10 to 13	P50 to P53	P50/D4 to P53/D7				
	Pins 14 to 17	P60/KR0 to P63/KR3	3		P60/KR0/D0 to P63/KR3/D3		
	Pin 21	IC	Vpp				
Other		Noise resistance and noise radiation may differ due to the different circuit sizes and mas layouts.					

#### Table 5-1. Differences Between $\mu$ PD75P3116 and $\mu$ PD753104, 753106, and 753108

Note 2<sup>17</sup>/fx: 21.8 ms at 6.0 MHz operation, 31.3 ms at 4.19 MHz operation 2<sup>15</sup>/fx: 5.46 ms at 6.0 MHz operation, 7.81 ms at 4.19 MHz operation

Caution There are differences in the amount of noise tolerance and noise radiation between flash memory versions and mask ROM versions. When considering changing from a flash memory version to a mask ROM version during the process from experimental manufacturing to mass production, make sure to sufficiently evaluate commercial samples (CS) (not engineering samples (ES)) of the mask ROM versions.

# 6. MEMORY CONFIGURATION

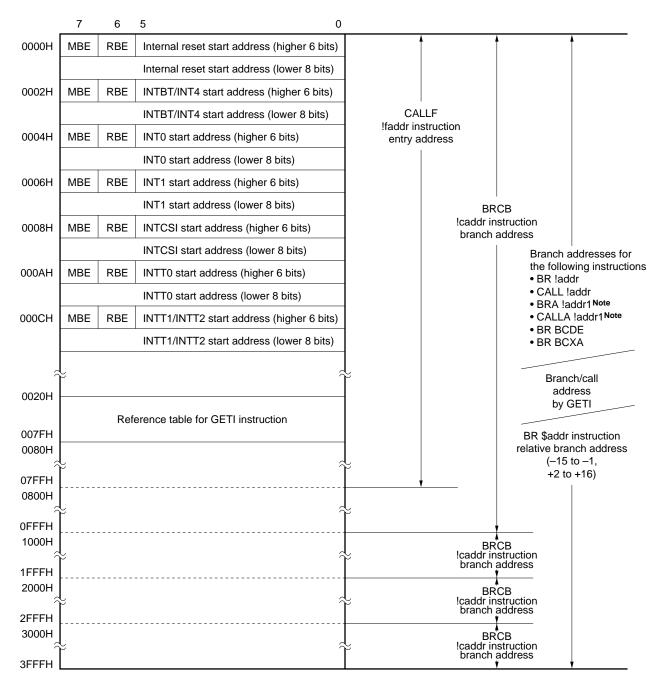
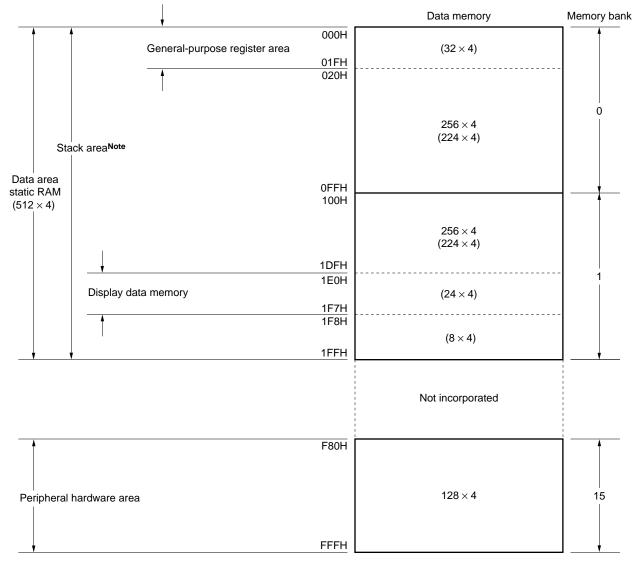


Figure 6-1. Program Memory Map

**Note** Can only be used in the Mk II mode.

**Remark** For instructions other than those noted above, the BR PCDE and BR PCXA instructions can be used to branch to addresses with changes in the PC's lower 8 bits only.

#### Figure 6-2. Data Memory Map



Note Memory bank 0 or 1 can be selected as the stack area.

# 7. INSTRUCTION SET

#### (1) Representation and coding formats for operands

In the instruction's operand area, use the following coding format to describe operands corresponding to the instruction's operand representations (for further details, refer to the **RA75X Assembler Package Language User's Manual (U12385E)**). When there are several codes, select and use just one. Codes that consist of uppercase letters and + or – symbols are keywords that should be entered as they are.

For immediate data, enter an appropriate numerical value or label.

Enter register flag symbols as label descriptors instead of mem, fmem, pmem, bit, etc. (for further details, refer to the **User's Manual**). The number of labels that can be entered for fmem and pmem are restricted.

Representation	Coding Format
reg	X, A, B, C, D, E, H, L
reg1	X, B, C, D, E, H, L
rp	XA, BC, DE, HL
rp1	BC, DE, HL
rp2	BC, DE
rp'	XA, BC, DE, HL, XA', BC', DE', HL'
rp'1	BC, DE, HL, XA', BC', DE', HL'
rpa	HL, HL+, HL–, DE, DL
rpa1	DE, DL
n4	4-bit immediate data or label
n8	8-bit immediate data or label
mem	8-bit immediate data or label <sup>Note</sup>
bit	2-bit immediate data or label
fmem	FB0H to FBFH, FF0H to FFFH immediate data or label
pmem	FC0H to FFFH immediate data or label
addr	0000H to 3FFFH immediate data or label
addr1	0000H to 3FFFH immediate data or label (Mk II mode only)
caddr	12-bit immediate data or label
faddr	11-bit immediate data or label
taddr	20H to 7FH immediate data (however, bit $0 = 0$ ) or label
PORTn	Port 0 to Port 3, Port 5, Port 6, Port 8, Port 9
IExxx	IEBT, IECSI, IET0 to IET2, IE0 to IE2, IE4, IEW
RBn	RB0 to RB3
MBn	MB0, MB1, MB15

Note When processing 8-bit data, only even-numbered addresses can be specified.

(2)	Operation	conventions
	A:	A register; 4-bit accumulator
	B:	B register
	C:	C register
	D:	D register
	E:	E register
	H:	H register
	L:	L register
	X:	X register
	XA:	Register pair (XA); 8-bit accumulator
	BC:	Register pair (BC)
	DE:	Register pair (DE)
	HL:	Register pair (HL)
	XA':	Expansion register pair (XA')
	BC':	Expansion register pair (BC')
	DE':	Expansion register pair (DE')
	HL':	Expansion register pair (HL')
	PC:	Program counter
	SP:	Stack pointer
	CY:	Carry flag; bit accumulator
	PSW:	Program status word
	MBE:	Memory bank enable flag
	RBE:	Register bank enable flag
	PORTn:	Port n (n = 0 to 3, 5, 6, 8, 9)
	IME:	Interrupt master enable flag
	IPS:	Interrupt priority selection register
	IE×××:	Interrupt enable flag
	RBS:	Register bank selection register
	MBS:	Memory bank selection register
	PCC:	Processor clock control register
	.:	Delimiter for address and bit
	(××):	Data addressed with $\times\!\!\times$
	××H:	Hexadecimal data

#### (3) Description of symbols used in addressing area

	MB = MBE • MBS	<b>A</b>
*1	MBS = 0, 1, 15	
*2	MB = 0	
	MBE = 0: MB = 0 (000H to 07FH)	
*3	MB = 15 (F80H to FFFH)	Data memory addressing
	MBE = 1: MB = MBS	
	MBS = 0, 1, 15	
*4	MB = 15, fmem = FB0H to FBFH, FF0H to FFFH	
*5	MB = 15, pmem = FC0H to FFFH	<b>V</b>
*6	addr = 0000H to 3FFFH	A
*7	addr, addr1 = (Current PC) - 15 to (Current PC) - 1	
	(Current PC) + 2 to (Current PC) + 16	
	caddr = 0000H to 0FFFH (PC13, 12 = 00B) or	
*0	1000H to 1FFFH (PC13, 12 = 01B) or	Program memory
*8	2000H to 2FFFH (PC13, 12 = 10B) or	addressing
	3000H to 3FFFH (PC13, 12 = 11B)	
*9	faddr = 0000H to 07FFH	
*10	taddr = 0020H to 007FH	
*11	addr1 = 0000H to 3FFFH (Mk II mode only)	•

Remarks 1. MB indicates access-enabled memory banks.

- 2. In area \*2, MB = 0 for both MBE and MBS.
- **3.** In areas \*4 and \*5, MB = 15 for both MBE and MBS.
- 4. Areas \*6 to \*11 indicate corresponding address-enabled areas.

#### (4) Description of machine cycles

S indicates the number of machine cycles required for skipping skip-specified instructions. The value of S varies as shown below.

- Skipped instruction is 1-byte or 2-byte instruction .... S = 1
- Skipped instruction is 3-byte instruction<sup>Note</sup> ...... S = 2

Note 3-byte instructions: BR !addr, BRA !addr1, CALL !addr, and CALLA !addr1

#### Caution The GETI instruction is skipped for one machine cycle.

One machine cycle equals one cycle (=  $t_{CY}$ ) of the CPU clock  $\Phi$ . Use the PCC setting to select from among four cycle times.

Instruction Group	Mnemonic	Operand	No. of Bytes	Machine Cycle	Operation	Addressing Area	Skip Condition
Transfer	MOV	A, #n4	1	1	A ← n4		String-effect A
		reg1, #n4	2	2	reg1 ← n4		
		XA, #n8	2	2	XA ← n8		String-effect A
		HL, #n8	2	2	HL ← n8		String-effect B
		rp2, #n8	2	2	rp2 ← n8		
		A, @HL	1	1	$A \leftarrow (HL)$	*1	
		A, @HL+	1	2+S	$A \leftarrow (HL)$ , then $L \leftarrow L+1$	*1	L = 0
		A, @HL-	1	2+S	A $\leftarrow$ (HL), then L $\leftarrow$ L–1	*1	L = FH
		A, @rpa1	1	1	A ← (rpa1)	*2	
		XA, @HL	2	2	$XA \leftarrow (HL)$	*1	
		@HL, A	1	1	$(HL) \leftarrow A$	*1	
		@HL, XA	2	2	$(HL) \leftarrow XA$	*1	
		A, mem	2	2	$A \leftarrow (mem)$	*3	
		XA, mem	2	2	$XA \leftarrow (mem)$	*3	
		mem, A	2	2	$(mem) \leftarrow A$	*3	
		mem, XA	2	2	$(mem) \leftarrow XA$	*3	
		A, reg	2	2	A ← reg		
		XA, rp'	2	2	XA ← rp'		
		reg1, A	2	2	reg1 ← A		
		rp'1, XA	2	2	rp'1 ← XA		
	ХСН	A, @HL	1	1	$A\longleftrightarrow(HL)$	*1	
		A, @HL+	1	2+S	$A \longleftrightarrow (HL)$ , then $L \leftarrow L+1$	*1	L = 0
		A, @HL-	1	2+S	$A \longleftrightarrow (HL)$ , then $L \leftarrow L-1$	*1	L = FH
		A, @rpa1	1	1	$A \longleftrightarrow (rpa1)$	*2	
		XA, @HL	2	2	$XA \longleftrightarrow (HL)$	*1	
		A, mem	2	2	$A\longleftrightarrow(mem)$	*3	
		XA, mem	2	2	$XA \longleftrightarrow (mem)$	*3	
		A, reg1	1	1	$A \longleftrightarrow reg1$		
		XA, rp'	2	2	$XA \longleftrightarrow rp'$		
Table	MOVT	XA, @PCDE	1	3	XA ← (PC13-8+DE)ROM		
reference		XA, @PCXA	1	3	XA ← (PC13-8+XA)rom		
		XA, @BCDE <sup>Note</sup>	1	3	XA ← (BCDE)roм	*6	
		XA, @BCXA <sup>Note</sup>	1	3	XA ← (BCXA)ROM	*6	

Note Only the lower 3 bits in the B register are valid.

Instruction Group	Mnemonic	Operand	No. of Bytes	Machine Cycle	Operation	Addressing Area	Skip Condition
Bit transfer	MOV1	CY, fmem.bit	2	2	$CY \gets (fmem.bit)$	*4	
		CY, pmem.@L	2	2	$CY \gets (pmem7-2+L3-2.bit(L1-0))$	*5	
		CY, @H+mem.bit	2	2	CY ← (H+mem3-0.bit)	*1	
		fmem.bit, CY	2	2	$(\textit{fmem.bit}) \leftarrow CY$	*4	
		pmem.@L, CY	2	2	(pmem7-2+L3-2.bit(L1-0)) ← CY	*5	
		@H+mem.bit, CY	2	2	(H+mem₃-o.bit) ← CY	*1	
Arithmetic	ADDS	A, #n4	1	1+S	$A \leftarrow A+n4$		carry
		XA, #n8	2	2+S	$XA \leftarrow XA{+}n8$		carry
		A, @HL	1	1+S	$A \leftarrow A\text{+}(HL)$	*1	carry
		XA, rp'	2	2+S	$XA \leftarrow XA \text{+rp'}$		carry
		rp'1, XA	2	2+S	$rp'1 \leftarrow rp'1+XA$		carry
	ADDC	A, @HL	1	1	$A,CY \gets A\text{+}(HL)\text{+}CY$	*1	
		XA, rp'	2	2	$XA, CY \gets XA \texttt{+} rp' \texttt{+} CY$		
		rp'1, XA	2	2	$rp'1, CY \leftarrow rp'1+XA+CY$		
	SUBS	A, @HL	1	1+S	$A \leftarrow A\text{-}(HL)$	*1	borrow
		XA, rp'	2	2+S	$XA \leftarrow XA\text{rp'}$		borrow
		rp'1, XA	2	2+S	rp'1 ← rp'1–XA		borrow
	SUBC	A, @HL	1	1	A, CY $\leftarrow$ A–(HL)–CY	*1	
		XA, rp'	2	2	$XA, CY \gets XArp\text{'-}CY$		
		rp'1, XA	2	2	rp'1, CY ← rp'1–XA–CY		
	AND	A, #n4	2	2	$A \leftarrow A \land n4$		
		A, @HL	1	1	$A \gets A \land (HL)$	*1	
		XA, rp'	2	2	$XA \leftarrow XA \wedge rp'$		
		rp'1, XA	2	2	$rp'1 \leftarrow rp'1 \land XA$		
	OR	A, #n4	2	2	A ← A v n4		
		A, @HL	1	1	$A \gets A \lor (HL)$	*1	
		XA, rp'	2	2	$XA \leftarrow XA v rp'$		
		rp'1, XA	2	2	rp'1 ← rp'1 v XA		
	XOR	A, #n4	2	2	A ← A ¥ n4		
		A, @HL	1	1	$A \gets A \not \forall (HL)$	*1	
		XA, rp'	2	2	$XA \leftarrow XA \forall rp'$		
		rp'1, XA	2	2	rp'1 ← rp'1 <del>v</del> XA		
Accumulator	RORC	А	1	1	$CY \leftarrow Ao, A3 \leftarrow CY, An-1 \leftarrow An$		
manipulation	NOT	А	2	2	$\overline{A} \to A$		
Increment/	INCS	reg	1	1+S	$reg \leftarrow reg+1$		reg = 0
decrement		rp1	1	1+S	rp1 ← rp1+1		rp1 = 00H
		@HL	2	2+S	$(HL) \leftarrow (HL)+1$	*1	(HL) = 0
		mem	2	2+S	$(mem) \leftarrow (mem)+1$	*3	(mem) = 0
	DECS	reg	1	1+S	reg ← reg–1		reg = FH
		rp'	2	2+S	rp' ← rp'–1		rp' = FFH

Instruction Group	Mnemonic	Operand	No. of Bytes	Machine Cycle	Operation	Addressing Area	Skip Condition
Comparison	SKE	reg, #n4	2	2+S	Skip if reg=n4		reg = n4
		@HL, #n4	2	2+S	Skip if (HL)=n4	*1	(HL) = n4
		A, @HL	1	1+S	Skip if A=(HL)	*1	A = (HL)
		XA, @HL	2	2+S	Skip if XA=(HL)	*1	XA = (HL)
		A, reg	2	2+S	Skip if A=reg		A = reg
		XA, rp'	2	2+S	Skip if XA=rp'		XA = rp'
Carry flag	SET1	CY	1	1	CY ← 1		
manipulation	CLR1	CY	1	1	$CY \leftarrow 0$		
	SKT	CY	1	1+S	Skip if CY=1		CY = 1
	NOT1	CY	1	1	$CY \leftarrow \overline{CY}$		
Memory bit	SET1	mem.bit	2	2	(mem.bit) ← 1	*3	
manipulation		fmem.bit	2	2	(fmem.bit) ← 1	*4	
		pmem.@L	2	2	(pmem7-2+L3-2.bit(L1-0)) ← 1	*5	
		@H+mem.bit	2	2	(H+mem₃-o.bit) ← 1	*1	
	CLR1	mem.bit	2	2	(mem.bit) ← 0	*3	
		fmem.bit	2	2	(fmem.bit) $\leftarrow$ 0	*4	
		pmem.@L	2	2	(pmem7-2+L3-2.bit(L1-0)) ← 0	*5	
		@H+mem.bit	2	2	(H+mem₃-₀.bit) ← 0	*1	
	SKT	mem.bit	2	2+S	Skip if(mem.bit)=1	*3	(mem.bit) = 1
		fmem.bit	2	2+S	Skip if(fmem.bit)=1	*4	(fmem.bit) = 1
		pmem.@L	2	2+S	Skip if(pmem7-2+L3-2.bit(L1-0))=1	*5	(pmem.@L) = 1
		@H+mem.bit	2	2+S	Skip if(H+mem3-0.bit)=1	*1	(@H+mem.bit) = 1
	SKF	mem.bit	2	2+S	Skip if(mem.bit)=0	*3	(mem.bit) = 0
		fmem.bit	2	2+S	Skip if(fmem.bit)=0	*4	(fmem.bit) = 0
		pmem.@L	2	2+S	Skip if(pmem7-2+L3-2.bit(L1-0))=0	*5	(pmem.@L) = 0
		@H+mem.bit	2	2+S	Skip if(H+mem₃-٥.bit)=0	*1	(@H+mem.bit) = 0
	SKTCLR	fmem.bit	2	2+S	Skip if(fmem.bit)=1 and clear	*4	(fmem.bit) = 1
		pmem.@L	2	2+S	Skip if(pmem7-2+L3-2.bit(L1-0))=1 and clear	*5	(pmem.@L) = 1
		@H+mem.bit	2	2+S	Skip if(H+mem3-0.bit)=1 and clear	*1	(@H+mem.bit) = 1
	AND1	CY, fmem.bit	2	2	$CY \leftarrow CY \land (fmem.bit)$	*4	
		CY, pmem.@L	2	2	$CY \leftarrow CY \land (pmem7-2+L3-2.bit(L1-0))$	*5	
		CY, @H+mem.bit	2	2	$CY \leftarrow CY \land (H+mem_{3-0}.bit)$	*1	
	OR1	CY, fmem.bit	2	2	$CY \leftarrow CY \vee (fmem.bit)$	*4	
		CY, pmem.@L	2	2	CY ← CY v (pmem7-2+L3-2.bit(L1-0))	*5	
		CY, @H+mem.bit	2	2	CY ← CY v (H+mem₃-o.bit)	*1	
	XOR1	CY, fmem.bit	2	2	$CY \leftarrow CY \forall$ (fmem.bit)	*4	
		CY, pmem.@L	2	2	$CY \leftarrow CY \forall (pmem7-2+L3-2.bit(L1-0))$	*5	
		CY, @H+mem.bit		2	$CY \leftarrow CY \forall (H+mem_{3-0}.bit)$	*1	

Instruction Group	Mnemonic	Operand	No. of Bytes	Machine Cycle	Operation	Addressing Area	Skip Condition
Branch B	BR <sup>Note 1</sup>	addr	_		PC13-0 ← addr Use the assembler to select the most appropriate instruction among the following. • BR !addr • BRCB !caddr • BR \$addr	*6	
		addr1			PC13-0 ← addr1 Use the assembler to select the most appropriate instruction among the following. • BRA !addr1 • BR !addr • BRCB !caddr • BR \$addr1	*11	
		!addr	3	3	PC13-0 ← addr	*6	
		\$addr	1	2	PC13-0 ← addr	*7	
		\$addr1	1	2	PC13-0 ← addr1		
		PCDE	2	3	PC13-0 ← PC13-8+DE		
		PCXA	2	3	$PC_{13-0} \leftarrow PC_{13-8+XA}$		
		BCDE	2	3	$PC_{13\text{-}0} \leftarrow BCDE^{Note 2}$	*6	
		BCXA	2	3	$PC_{13\text{-}0} \leftarrow BCXA^{Note 2}$	*6	
	BRA <sup>Note 1</sup>	!addr1	3	3	PC13-0 ← addr1	*11	
	BRCB	!caddr	2	2	$PC_{13-0} \leftarrow PC_{13, 12+caddr_{11-0}}$	*8	

Notes 1. The sections in double boxes are only supported in the Mk II mode. The other sections are only supported in the MK I mode.

2. Only the lower two bits in the B register are valid.

Instruction Group	Mnemonic	Operand	No. of Bytes	Machine Cycle	Operation	Addressing Area	Skip Condition
Subroutine	CALLANote	!addr1	3	3	(SP–6)(SP–3)(SP–4) ← PC11-0	*11	
stack control					(SP–5) ← 0, 0, PC13, 12		
					$(SP-2) \leftarrow X, X, MBE, RBE$		
					$PC_{13\text{-}0} \leftarrow addr_1, SP \leftarrow SP_{-\!6}$		
	CALL <sup>Note</sup>	!addr	3	3	(SP-4)(SP-1)(SP-2) ← PC11-0	*6	
					$(SP-3) \leftarrow MBE, RBE, PC13, 12$		
					$PC_{13\text{-}0} \leftarrow addr,  SP \leftarrow SP\text{-}4$		
				4	(SP–6)(SP–3)(SP–4) ← PC11-0		
					(SP–5) ← 0, 0, PC13, 12		
					$(SP-2) \leftarrow X, X, MBE, RBE$		
					$PC_{13\text{-}0} \leftarrow addr,  SP \leftarrow SP\text{-}6$		
	CALLF <sup>Note</sup>	!faddr	2	2	(SP-4)(SP-1)(SP-2) ← PC11-0	*9	
					$(SP-3) \leftarrow MBE, RBE, PC_{13, 12}$		
					$PC_{13\text{-}0} \gets 000\text{+faddr},  SP \gets SP\text{-4}$		
				3	(SP-6)(SP-3)(SP-4) ← PC11-0		
					(SP–5) ← 0, 0, PC13, 12		
					$(SP-2) \leftarrow X, X, MBE, RBE$		
					$PC_{13\text{-}0} \leftarrow 000\text{+faddr},  SP \leftarrow SP\text{-6}$		
	RET <sup>Note</sup>		1	3	MBE, RBE, PC13, 12 ← (SP+1)		
					$PC_{11-0} \leftarrow (SP)(SP+3)(SP+2)$		
					$SP \leftarrow SP+4$		
					$X, X, MBE, RBE \leftarrow (SP+4)$		
					PC11-0 ← (SP)(SP+3)(SP+2)		
					0, 0, PC13, 12 ← (SP+1)		
					$SP \leftarrow SP+6$		
	RETS <sup>Note</sup>		1	3+S	MBE, RBE, PC13, 12 ← (SP+1)		Unconditional
					$PC_{11-0} \leftarrow (SP)(SP+3)(SP+2)$		
					$SP \leftarrow SP+4$		
					then skip unconditionally		
					$X, X, MBE, RBE \leftarrow (SP+4)$		
					PC11-0 ← (SP)(SP+3)(SP+2)		
					0, 0, PC13, 12 ← (SP+1)		
					$SP \leftarrow SP+6$		
					then skip unconditionally		
	RETI <sup>Note</sup>		1	3	MBE, RBE, PC13, 12 ← (SP+1)		
					$PC_{11-0} \leftarrow (SP)(SP+3)(SP+2)$		
					$PSW \leftarrow (SP+4)(SP+5)$		
					$SP \leftarrow SP+6$		
					0, 0, PC13, 12 ← (SP+1)		
					$PC_{11\text{-}0} \leftarrow (SP)(SP+3)(SP+2)$		
					$PSW \leftarrow (SP+4)(SP+5),  SP \leftarrow SP+6$		

Note The sections in double boxes are only supported in the Mk II mode. The other sections are only supported in the Mk I mode.

Instruction Group	Mnemonic	Operand	No. of Bytes	Machine Cycle	Operation	Addressing Area	Skip Condition
Subroutine	PUSH	rp	1	1	$(SP-1)(SP-2) \leftarrow rp, SP \leftarrow SP-2$		
stack control		BS	2	2	$(SP-1) \leftarrow MBS, (SP-2) \leftarrow RBS, SP \leftarrow SP-2$		
	POP	rp	1	1	$rp \leftarrow (SP+1)(SP), SP \leftarrow SP+2$		
		BS	2	2	$MBS \leftarrow (SP+1), RBS \leftarrow (SP), SP \leftarrow SP+2$		
Interrupt	EI		2	2	IME(IPS.3) ← 1		
control		IE×××	2	2	$IE \times \times \leftarrow 1$		
	DI		2	2	$IME(IPS.3) \leftarrow 0$		
		IE×××	2	2	$IE \times \times \leftarrow 0$		
I/O	IN <sup>Note 1</sup>	A, PORTn	2	2	A ← PORTn (n=0 to 3, 5, 6, 8, 9)		
		XA, PORTn	2	2	$XA \leftarrow PORTn+1, PORTn (n=8)$		
	OUT <sup>Note 1</sup>	PORTn, A	2	2	PORTn ← A (n=2 to 3, 5, 6, 8, 9)		
		PORTn, XA	2	2	PORTn+1, PORTn $\leftarrow$ XA (n=8)		
CPU control	HALT		2	2	Set HALT Mode(PCC.2 $\leftarrow$ 1)		
	STOP		2	2	Set STOP Mode(PCC.3 $\leftarrow$ 1)		
	NOP		1	1	No Operation		
Special	SEL	RBn	2	2	$RBS \leftarrow n (n=0 \text{ to } 3)$		
		MBn	2	2	MBS ← n (n=0, 1, 15)		
	GETI <sup>Notes 2, 3</sup>	taddr	1	3	When using TBR instruction	*10	
					$PC_{13-0} \leftarrow (taddr)_{5-0}+(taddr+1)$		
					When using TCALL instruction	-	
					(SP-4)(SP-1)(SP-2) ← PC11-0		
					$(SP-3) \leftarrow MBE, RBE, PC_{13, 12}$		
					PC13-0 ← (taddr)5-0+(taddr+1)		
					$SP \leftarrow SP-4$		
					When using instruction other than TBR or TCALL Execute (taddr)(taddr+1) instructions		Determined by referenced instruction
			1	3	When using TBR instruction	*10	
					PC13-0 ← (taddr)5-0+(taddr+1)		
				4	When using TCALL instruction	•	
					(SP–6)(SP–3)(SP–4) ← PC11-0		
					(SP–5) ← 0, 0, PC13, 12		
					$(SP-2) \leftarrow X, X, MBE, RBE$		
					PC13-0 ← (taddr)5-0+(taddr+1)		
					$SP \leftarrow SP-6$		
				3	<ul> <li>When using instruction other than TBR or TCALL Execute (taddr)(taddr+1) instructions</li> </ul>		Determined by referenced instruction

Notes 1. Setting MBE = 0 or MBE = 1, MBS = 15 is required during the execution of the IN or OUT instruction.

- 2. The TBR and TCALL instructions are assembler quasi-directives for the GETI instruction table definitions.
- 3. The sections in double boxes are only supported in the Mk II mode. The other sections are only supported in the Mk I mode.

# 8. ONE-TIME PROM (PROGRAM MEMORY) WRITE AND VERIFY

The program memory contained in the  $\mu$ PD75P3116 is a 16384 × 8-bit one-time PROM that can be electrically written one time only. The pins listed in the table below are used for this PROM's write/verify operations. Clock input from the X1 pin is used instead of address input as a method for updating addresses.

Pin	Function
Vpp	Pin where program voltage is applied during program memory write/verify (usually VDD potential)
X1, X2	Clock input pins for address updating during program memory write/verify. Input the X1 pin's inverted signal to the X2 pin.
MD0 to MD3	Operation mode selection pin for program memory write/verify
D0/P60 to D3/P63 (lower 4 bits) D4/P50 to D7/P53 (higher 4 bits)	8-bit data I/O pins for program memory write/verify
Vdd	Pin where power supply voltage is applied. Apply 1.8 to 5.5 V in normal operation mode and +6 V for program memory write/ verify.

Caution Pins not used for program memory write/verify should be connected to Vss.

#### 8.1 Operation Modes for Program Memory Write/Verify

When +6 V is applied to the V<sub>DD</sub> pin and +12.5 V to the V<sub>PP</sub> pin, the  $\mu$ PD75P3116 enters the program memory write/ verify mode. The following operation modes can be specified by setting pins MD0 to MD3 as shown below.

	Operation Mode Specification					Operation Mode
Vpp	Vdd	MD0	MD1	MD2	MD3	
+12.5 V	+6 V	н	L	Н	L	Zero-clear program memory address
		L	Н	Н	Н	Write mode
		L	L	н	н	Verify mode
		н	×	Н	Н	Program inhibit mode

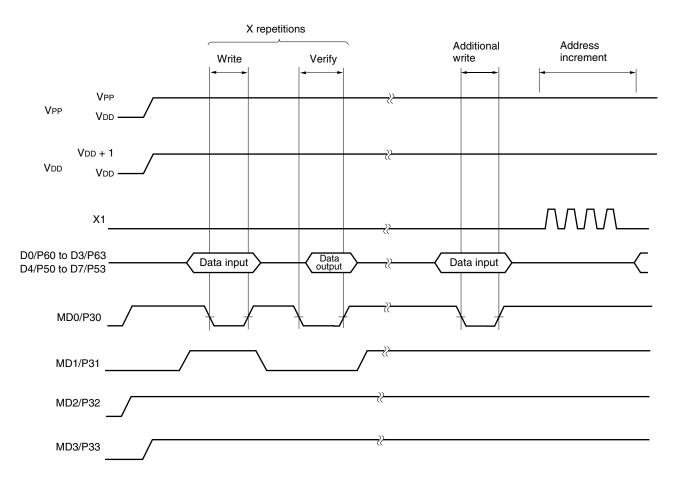
 $\times:$  L or H

#### 8.2 Program Memory Write Procedure

Program memory can be written at high speed using the following procedure.

- (1) Pull down unused pins to Vss via resistors. Set the X1 pin to low.
- (2) Supply 5 V to the VDD and VPP pins.
- (3) Wait 10 μs.
- (4) Select the program memory address zero-clear mode.
- (5) Supply 6 V to VDD and 12.5 V to VPP.
- (6) Write data in the 1 ms write mode.
- (7) Select the verify mode. If the data is written, go to (8) and if not, repeat (6) and (7).
- (8) Additional write. (X: Number of write operations from (6) and (7))  $\times$  1 ms
- (9) Apply four pulses to the X1 pin to increment the program memory address by one.
- (10) Repeat (6) to (9) until the end address is reached.
- (11) Select the program memory address zero-clear mode.
- (12) Return the VDD- and VPP-pin voltages to 5 V.
- (13) Turn off the power.

The following figure shows steps (2) to (9).

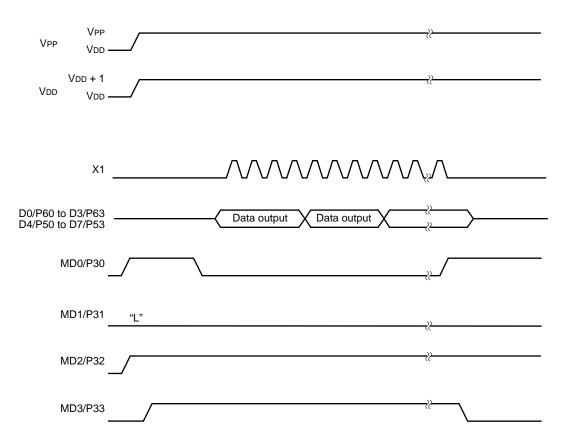


#### 8.3 Program Memory Read Procedure

The  $\mu$ PD75P3116 can read program memory contents using the following procedure.

- (1) Pull down unused pins to Vss via resistors. Set the X1 pin to low.
- (2) Supply 5 V to the VDD and VPP pins.
- (3) Wait 10 μs.
- (4) Select the program memory address zero-clear mode.
- (5) Supply 6 V to V\_DD and 12.5 V to V\_PP.
- (6) Select the verify mode. Apply four pulses to the X1 pin. The data stored in one address will be output every four clock pulses.
- (7) Select the program memory address zero-clear mode.
- (8) Return the VDD- and VPP-pin voltages to 5 V.
- (9) Turn off the power.

The following figure shows steps (2) to (7).



#### 8.4 One-Time PROM Screening

Due to its structure, the one-time PROM cannot be fully tested before shipment by NEC. Therefore, NEC recommends that after the required data is written and the PROM is stored under the temperature and time conditions shown below, the PROM should be verified via screening.

Storage Temperature	Storage Time
125°C	24 hours

NEC offers QTOP microcontrollers for which one-time PROM writing, marking, screening, and verification are provided at additional cost. For further details, contact an NEC sales representative.

# 9. ELECTRICAL SPECIFICATIONS

#### Absolute Maximum Ratings (T<sub>A</sub> = 25°C)

Parameter	Symbol	Test Conditions	Rating	Unit
Power supply voltage	Vdd		-0.3 to +7.0	V
PROM power supply voltage	Vpp		-0.3 to +13.5	V
Input voltage	VI1	Except port 5	-0.3 to V <sub>DD</sub> + 0.3	V
	V <sub>12</sub>	Port 5 (N-ch open drain)	-0.3 to +14	V
Output voltage	Vo		-0.3 to VDD + 0.3	V
Output current, high	Іон	Per pin	-10	mA
		Total of all pins	-30	mA
Output current, low	lo∟	Per pin	30	mA
		Total of all pins	220	mA
Operating ambient temperature	TA		-40 to +85 <sup>Note</sup>	°C
Storage temperature	Tstg		-65 to +150	°C

**Note** When LCD is driven in normal mode:  $T_A = -10$  to +85°C

Capacitance ( $T_A = 25^{\circ}C$ ,  $V_{DD} = 0 V$ )

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Input capacitance	CIN	f = 1 MHz			15	pF
Output capacitance	Соит	Unmeasured pins returned to 0 V.			15	pF
I/O capacitance	Сю				15	pF

Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.

Recommended Constant	Parameter	Test Conditions	MIN.	TYP.	MAX.	Unit
X1 X2	Oscillation		1.0		6.0 <sup>Note 2</sup>	MHz
	frequency (fx) <sup>Note 1</sup>					
	Oscillation	After VDD reaches oscil-			4	ms
'' VDD	stabilization time <sup>Note 3</sup>	lation voltage range MIN.				
X1 X2	Oscillation		1.0		6.0 <sup>Note 2</sup>	MHz
	frequency (fx) <sup>Note 1</sup>					
	Oscillation	VDD = 4.5 to 5.5 V			10	ms
V <sub>DD</sub>	stabilization time <sup>Note 3</sup>	VDD = 1.8 to 5.5 V			30	
	X1 input		1.0		6.0 <sup>Note 2</sup>	MHz
X1 X2	frequency (fx) <sup>Note 1</sup>					
	X1 input		83.3		500	ns
	high-/low-level width (tхн, tх∟)					
	$\begin{array}{c} x_1 \\ c_1 \\ \hline \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ $	$x_1$ $x_2$ Oscillation frequency (fx)Note 1 $C_1$ $\downarrow$ $\downarrow$ $\bigcirc$ $V_{DD}$ $C_2$ $\bigcirc$ Oscillation stabilization timeNote 3 $\downarrow$ $\downarrow$ $\downarrow$ $\bigcirc$ $C_1$ $\downarrow$ $\bigcirc$ $\bigcirc$ $\downarrow$ $\downarrow$ $\bigcirc$ $\bigcirc$ $C_1$ $\downarrow$ $\bigcirc$ $\bigcirc$ $\downarrow$ $\downarrow$ $\downarrow$ $\bigcirc$ $\downarrow$ <	$x_1$ $x_2$ frequency $(fx)^{Note 1}$ Oscillation frequency $(fx)^{Note 1}$ $C_1$ $V_{DD}$ $C_2$ $C_2$ $V_{DD}$ $C_2$ $C_2$ $C_2$ $C_1$ $C_2$ $C_2$ $C_2$ $C_1$ $C_2$ $C_2$ $C_2$ $C_1$ $C_2$ $C_2$ $C_2$ $V_{DD}$ $C_2$ $C_2$ $V_{DD} = 4.5 \text{ to } 5.5 \text{ V}$ $C_1$ $C_2$ $C_2$ $C_2$ $V_{DD}$ $C_2$ $C_2$ $V_{DD} = 1.8 \text{ to } 5.5 \text{ V}$ $V_{DD}$ $C_2$ $X_1$ input frequency $(fx)^{Note 1}$ $X_1$ input high-/low-level width $X_1$ input high-/low-level width	X1X2Oscillation frequency (fx)^Note 11.0C1 $V_{DD}$ C2Oscillation stabilization timeNote 3After V_{DD} reaches oscillation voltage range MIN. $V_{DD}$ $V_{DD}$ Oscillation frequency (fx)^Note 1After V_{DD} reaches oscillation voltage range MIN. $V_{DD}$	$x_1$ $x_2$ frequency (fx)Note 1Oscillation frequency (fx)Note 11.0 $C_1$ $V_{DD}$ $C_2$ $Oscillation$ stabilization timeNote 3 $After V_{DD}$ reaches oscillation voltage range MIN. $x_1$ $x_2$ $V_{DD}$ $Oscillation$ frequency (fx)Note 1 $1.0$ $C_1$ $C_2$ $Oscillation$ frequency (fx)Note 1 $1.0$ $V_{DD}$ $C_2$ $Oscillation$ frequency (fx)Note 1 $V_{DD}$ $X_1$ $X_2$ $V_{DD}$ $V_{DD}$ $1.8$ to $5.5 V$ $X_1$ $X_1$ $Note 1$ $1.0$ $X_1$ $Note 1$ $1.0$ $X_1$ $Note 1$ $1.0$ $X_1$ $Note 1$ $X_1$	$X1$ $X2$ frequency (fx)Note 1 $1.0$ $6.0^{Note 2}$ $C1$ $V_{DD}$ $C2$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $V_{DD}$ $C2$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $V_{DD}$ $C2$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $C1$ $V_{DD}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $C1$ $V_{DD}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $C1$ $G_{C2}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $C1$ $V_{DD}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $C1$ $G_{C2}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $C1$ $G_{C2}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $C1$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $G_{C1}$ $C1$ $G_{C2}$ $G_{C1}$

#### Main System Clock Oscillator Characteristics (TA = -40 to $+85^{\circ}$ C, VDD = 1.8 to 5.5 V)

- Notes 1. Indicates only oscillator characteristics. Refer to AC Characteristics for instruction execution time.
   When the power supply voltage is 1.8 V ≤ V<sub>DD</sub> < 2.7 V and the oscillation frequency is 4.19 MHz < fx ≤ 6.0 MHz, setting the processor clock control register (PCC) to 0011 makes 1 machine cycle less than the required 0.95 μs. Therefore, set PCC to a value other than 0011.</li>
  - 3. The oscillation stabilization time is necessary for oscillation to stabilize after applying VDD or releasing the STOP mode.
- Caution When using the main system clock oscillator, wire as follows in the area enclosed by the broken lines in the above figures to avoid an adverse effect from wiring capacitance.
  - Keep the wiring length as short as possible.
  - Do not cross the wiring with the other signal lines.
  - Do not route the wiring near a signal line through which a high fluctuating current flows.
  - Always make the ground point of the oscillator capacitor the same potential as  $V_{\mbox{\scriptsize DD}}.$
  - Do not ground the capacitor to a ground pattern through which a high current flows.
  - Do not fetch signals from the oscillator.

Resonator	Recommended Constant	Parameter	Test Conditions	MIN.	TYP.	MAX.	Unit
Crystal	XT1 XT2	Oscillation		32	32.768	35	kHz
resonator		frequency $(f_{XT})^{Note 1}$					
	$C_3 \downarrow \square \downarrow C_4$	Oscillation	$V_{DD} = 4.5 \text{ to } 5.5 \text{ V}$		1.0	2	S
	VDD	stabilization time <sup>Note 2</sup>	$V_{DD} = 1.8$ to 5.5 V			10	
External	1 1	XT1 input frequency		32		100	kHz
clock	XT1 XT2	(f <sub>XT</sub> ) <sup>Note 1</sup>					
		XT1 input high-/low-level		5		15	μs
		width (txth, txtl)					

#### Subsystem Clock Oscillator Characteristics ( $T_A = -40$ to $+85^{\circ}C$ , $V_{DD} = 1.8$ to 5.5 V)

Notes 1. Indicates only oscillator characteristics. Refer to AC Characteristics for instruction execution time.
 2. The oscillation stabilization time is necessary for oscillation to stabilize after applying VDD.

Caution When using the subsystem clock oscillator, wire as follows in the area enclosed by the broken lines in the above figures to avoid an adverse effect from wiring capacitance.

- Keep the wiring length as short as possible.
- Do not cross the wiring with the other signal lines.
- Do not route the wiring near a signal line through which a high fluctuating current flows.
- Always make the ground point of the oscillator capacitor the same potential as VDD.
- Do not ground the capacitor to a ground pattern through which a high current flows.
- Do not fetch signals from the oscillator.

The subsystem clock oscillator is designed as a low amplification circuit to provide low consumption current, and is more liable to misoperation by noise than the main system clock oscillator. Special care should therefore be taken regarding the wiring method when the subsystem clock is used.

Parameter	Symbol		Test Conditions	S	MIN.	TYP.	MAX.	Unit
Output current, low	Iol	Per pin					15	mA
		Total of all p	Total of all pins				150	mA
Input voltage, high	VIH1	Ports 2, 3, 8	and 9 $2.7 \le V_{DD} \le 5.5 \text{ V}$		0.7Vdd		Vdd	V
				$1.8 \le V_{\text{DD}} < 2.7 \text{ V}$	0.9Vdd		Vdd	V
	VIH2	Ports 0, 1, 6	, RESET	$2.7 \le V_{\text{DD}} \le 5.5 \text{ V}$	0.8Vdd		Vdd	V
				$1.8 \le V_{\text{DD}} < 2.7 \text{ V}$	0.9Vdd		Vdd	V
	Vінз	Port 5		$2.7 \le V_{\text{DD}} \le 5.5 \text{ V}$	0.7Vdd		13	V
		(N-ch open-c	drain)	$1.8 \le V_{DD} < 2.7 V$	0.9Vdd		13	V
	VIH4	X1, XT1			Vdd - 0.1		Vdd	V
Input voltage, low	VIL1	Ports 2, 3, 5	, 8, and 9	$2.7 \leq V_{\text{DD}} \leq 5.5 \text{ V}$	0		0.3Vdd	V
				$1.8 \leq V_{DD} < 2.7 V$	0		0.1Vdd	V
	VIL2	Ports 0, 1, 6	, RESET	$2.7 \leq V_{\text{DD}} \leq 5.5 \text{ V}$	0		0.2Vdd	V
				$1.8 \le V_{DD} < 2.7 V$	0		0.1Vdd	V
	VIL3	X1, XT1	(1, XT1				0.1	V
Output voltage, high	Vон	SCK, SO, Ports 2, 3, 6, 8, and 9 Іон = -1.0 mA						V
Output voltage, low	Vol1	SCK, SO, Ports 2, 3, 5, 6, 8, and 9		Io∟ = 15 mA, V <sub>DD</sub> = 4.5 to 5.5 V		0.2	2.0	V
				lo∟ = 1.6 mA			0.4	V
	Vol2	SB0, SB1	$ \begin{array}{lll} \text{SB1} & \text{When N-ch open-drain} \\ & \text{pull-up resistor} \geq 1 \ k\Omega \end{array} $				0.2Vdd	V
Input leakage	Ілні	Vin = Vdd	Pins other than X1,	XT1			3	μA
current, high	ILIH2		X1, XT1				20	μA
	Ілнз	VIN = 13 V	Port 5 (N-ch open-d	rain)			20	μA
Input leakage		$V_{IN} = 0 V$	Pins other than X1,	XT1, and Port 5			-3	μA
current, low	ILIL2		X1, XT1				-20	μA
	Ililis		Port 5 (N-ch open-drain) When another instruction than input instruction is executed				-3	μA
			Port 5 (N-ch open-drain)	V <sub>DD</sub> = 1.8 to 5.5 V			-30	μA
			When input	VDD = 5.0 V		-10	-27	μA
			instruction is executed	VDD = 3.0 V		-3	-8	μA
Output leakage	ILOH1	Vout = Vdd	SCK, SO/SB0, SB1, Ports 2, 3, 6, 8, and 9				3	μA
current, high	ILOH2	Vout = 13 V	Port 5 (N-ch open-d	rain)			20	μA
Output leakage current, low	Ilol	Vout = 0 V					-3	μA
On-chip pull-up resistor	R∟	Vin = 0 V	Ports 0, 1, 2, 3, 6, 8 (Excluding P00 pin)	, and 9	50	100	200	kΩ

# DC Characteristics (T<sub>A</sub> = -40 to $+85^{\circ}$ C, V<sub>DD</sub> = 1.8 to 5.5 V)

Parameter	Symbol		Test Conditi	ons		MIN.	TYP.	MAX.	Unit
LCD drive voltage	VLCD	VAC0 = 0	$T_{A} = -40$ to +	85°C		2.7		Vdd	V
			$T_{A} = -10 \text{ to } +$	85°C		2.2		Vdd	V
		VAC0 = 1				1.8		Vdd	V
VAC current <sup>Note 1</sup>	Ivac	VAC0 = 1, VDD =	2.0 V ±10%				1	4	μA
LCD output voltage deviation <sup>Note 2</sup> (common)	Vodc	lo = ±1.0 μA	VLCD0 = VLCD VLCD1 = VLCD >	$V_{LCD0} = V_{LCD}$ $V_{LCD1} = V_{LCD} \times 2/3$				±0.2	V
LCD output voltage deviation <sup>Note 2</sup> (segment)	Vods	lo = ±0.5 μA		$V_{LCD2} = V_{LCD} \times 1/3$ 1.8 V $\leq$ V_{LCD} $\leq$ V_{DD}				±0.2	V
Supply currentNote 3	Idd1	6.00 MHz <sup>Note 4</sup>	$V_{DD} = 5.0 V \pm$	= 5.0 V ±10% <sup>Note 5</sup>			3.2	9.5	mA
		Crystal oscillation	VDD = 3.0 V ±10% <sup>Note 6</sup>			0.55	1.6	mA	
	IDD2	C1 = C2 = 22 pF	HALT mode	VDD = 5.0	V ±10%		0.7	2.0	mA
				V <sub>DD</sub> = 3.0 V ±10%			0.25	0.8	mA
	IDD1	4.19 MHz <sup>Note 4</sup>	$V_{DD} = 5.0 V \pm$				2.5	7.5	mA
		Crystal oscillation	VDD = 3.0 V ±				0.45	1.35	mA
	IDD2 C1 = C2 = 22 pF HALT mode VDD = 5.0 V ±10%		V ±10%		0.65	1.8	mA		
				VDD = 3.0	V ±10%		0.22	0.7	mA
	Іддз	32.768 kHz <sup>Note 7</sup>	Low-voltage	VDD = 3.0	V ±10%		45	130	μA
		Crystal oscillation	mode <sup>Note 8</sup>	VDD = 2.0	V ±10%		20	55	μA
				VDD = 3.0 V	, T <sub>A</sub> = 25°C		45	90	μA
			Low current	VDD = 3.0	V ±10%		42	120	μA
			consumption mode <sup>Note 9</sup>	VDD = 3.0	V, T <sub>A</sub> = 25°C		42	85	μA
	IDD4		HALT mode	Low-	Vdd = 3.0 V ±10%		5.5	18	μA
				voltage	Vdd = 2.0 V ±10%		2.2	7	μA
				mode <sup>Note 8</sup>	Vdd = 3.0 V, Ta = 25°C		5.5	12	μA
			Low	Low current	VDD = 3.0 V ±10%		4.0	12	μA
			consump- tion mode			4.0	8	μΑ	
	IDD5 XT1 = 0 V <sup>Note 10</sup> VDD = 5.0 V		VDD = 5.0 V ±				0.05	10	μA
		STOP mode	VDD = 3.0 V	$T_{A} = -40$	to +85°C		0.02	5	μA
			±10%	T <sub>A</sub> = 25°C			0.02	3	μA

# DC Characteristics (T<sub>A</sub> = -40 to $+85^{\circ}$ C, V<sub>DD</sub> = 1.8 to 5.5 V)

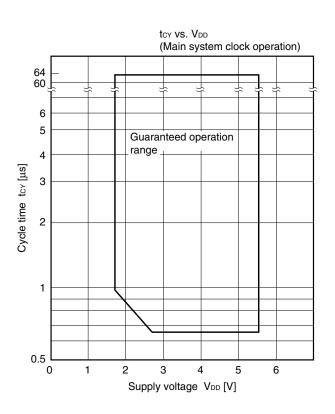
**Notes 1.** Set to VAC0 = 0 when the low current consumption mode and the stop mode are used. If VAC0 = 1 is set, the current increases for approx. 1  $\mu$ A.

- 2. The voltage deviation is the difference from the output voltage corresponding to the ideal value of the segment and common outputs (VLCDn; n = 0, 1, 2).
- 3. Not including currents flowing through on-chip pull-up resistors.
- 4. Including oscillation of the subsystem clock.
- 5. When the processor clock control register (PCC) is set to 0011 and the device is operated in the high-speed mode.
- 6. When PCC is set to 0000 and the device is operated in the low-speed mode.
- **7.** When the system clock control register (SCC) is set to 1001 and the device is operated on the subsystem clock, with main system clock oscillation stopped.
- 8. When the sub-oscillator control register (SOS) is set to 0000.
- 9. When SOS is set to 0010.
- **10.** When SOS is set to  $00 \times 1$  and the feedback resistor of the sub-oscillator is not used ( $\times$ : Don't care).

Parameter	Symbol	Test Co	onditions	MIN.	TYP.	MAX.	Unit
CPU clock cycle	tcy	Operating on	V <sub>DD</sub> = 2.7 to 5.5 V	0.67		64	μs
time <sup>Note 1</sup>		main system clock	V <sub>DD</sub> = 1.8 to 5.5 V	0.95		64	μs
(Min. instruction execution		Operating on subsystem cl	ock	114	122	125	μs
time = 1 machine cycle)							
TI0, TI1, TI2 input	f⊤ı	V <sub>DD</sub> = 2.7 to 5.5 V		0		1.0	MHz
frequency		V <sub>DD</sub> = 1.8 to 5.5 V				275	kHz
TI0, TI1, TI2 input	tтiн, tтi∟	V <sub>DD</sub> = 2.7 to 5.5 V		0.48			μs
high-/low-level width		V <sub>DD</sub> = 1.8 to 5.5 V					μs
Interrupt input high-/	tinth, tintl	INT0	IM02 = 0	Note 2			μs
low-level width			IM02 = 1	10			μs
		INT1, 2, 4		10			μs
		KR0 to KR7		10			μs
RESET low-level width	trsl			10			μs

AC Characteristics (T<sub>A</sub> = -40 to  $+85^{\circ}$ C, V<sub>DD</sub> = 1.8 to 5.5 V)

- Notes 1. The cycle time (minimum instruction execution time) of the CPU clock (Φ) is determined by the oscillation frequency of the connected resonator (and external clock), the system clock control register (SCC) and the processor clock control register (PCC). The figure on the right indicates the cycle time tcy versus supply voltage VDD characteristics with the main system clock operating.
  - 2. 2tcy or 128/fx is set by setting the interrupt mode register (IM0).



### **Serial Transfer Operation**

Parameter	Symbol	Test Co	onditions	MIN.	TYP.	MAX.	Unit
SCK cycle time	tксү1	V <sub>DD</sub> = 2.7 to 5.5 V		1300			ns
		V <sub>DD</sub> = 1.8 to 5.5 V		3800			ns
SCK high-/low-level	tк∟1, tкн1	V <sub>DD</sub> = 2.7 to 5.5 V		tксү1/2–50			ns
width		V <sub>DD</sub> = 1.8 to 5.5 V					ns
SINote 1 setup time	tsik1	V <sub>DD</sub> = 2.7 to 5.5 V		150			ns
(to SCK↑)		V <sub>DD</sub> = 1.8 to 5.5 V					ns
SI <sup>Note 1</sup> hold time	tksi1	V <sub>DD</sub> = 2.7 to 5.5 V		400			ns
(from SCK↑)		V <sub>DD</sub> = 1.8 to 5.5 V		600			ns
SO <sup>Note 1</sup> output delay	tkso1	R∟ = 1 kΩ,	VDD = 2.7 to 5.5 V	0		250	ns
time from $\overline{SCK}\downarrow$		CL = 100 pF <sup>Note 2</sup>	V <sub>DD</sub> = 1.8 to 5.5 V	0		1000	ns

2-wire and 3-wire serial I/O mode (SCK...Internal clock output): (TA = -40 to +85°C, VDD = 1.8 to 5.5 V)

Notes 1. In 2-wire serial I/O mode, read this parameter as SB0 or SB1 instead.

2.  $R_L$  and  $C_L$  are the load resistance and load capacitance of the SO output lines, respectively.

Parameter	Symbol	Test Co	nditions	MIN.	TYP.	MAX.	Unit
SCK cycle time	<b>t</b> ксү2	VDD = 2.7 to 5.5 V		800			ns
		VDD = 1.8 to 5.5 V	V <sub>DD</sub> = 1.8 to 5.5 V				ns
SCK high-/low-level	tкL2, tкн2	VDD = 2.7 to 5.5 V		400			ns
width		V <sub>DD</sub> = 1.8 to 5.5 V					ns
SI <sup>Note 1</sup> setup time	tsik2	V <sub>DD</sub> = 2.7 to 5.5 V		100			ns
(to SCK↑)		V <sub>DD</sub> = 1.8 to 5.5 V					ns
SI <sup>Note 1</sup> hold time	tksi2	V <sub>DD</sub> = 2.7 to 5.5 V	V <sub>DD</sub> = 2.7 to 5.5 V				ns
(from SCK↑)		V <sub>DD</sub> = 1.8 to 5.5 V		600			ns
SO <sup>Note 1</sup> output delay	tĸso2	R∟ = 1 kΩ,	V <sub>DD</sub> = 2.7 to 5.5 V	0		300	ns
time from $\overline{SCK}\downarrow$		C∟ = 100 pF <sup>Note 2</sup>	V <sub>DD</sub> = 1.8 to 5.5 V	0		1000	ns

Notes 1. In 2-wire serial I/O mode, read this parameter as SB0 or SB1 instead.

**2.**  $R_{L}$  and  $C_{L}$  are the load resistance and load capacitance of the SO output lines, respectively.

Parameter	Symbol	Test Cor	nditions	MIN.	TYP.	MAX.	Unit
SCK cycle time	tксүз	V <sub>DD</sub> = 2.7 to 5.5 V		1300			ns
		V <sub>DD</sub> = 1.8 to 5.5 V	3800			ns	
SCK high-/low-level	tкьз, tкнз	V <sub>DD</sub> = 2.7 to 5.5 V		tксүз/2–50			ns
width		V <sub>DD</sub> = 1.8 to 5.5 V		tксүз/2–150			ns
SB0, 1 setup time	tsik3	V <sub>DD</sub> = 2.7 to 5.5 V		150			ns
(to SCK↑)		V <sub>DD</sub> = 1.8 to 5.5 V		500			ns
SB0, 1 hold time (from $\overline{SCK}^{\uparrow}$ )	tหรเง			tксүз/2			ns
SB0, 1 output delay	tкsoз	RL = 1 kΩ,	V <sub>DD</sub> = 2.7 to 5.5 V	0		250	ns
time from $\overline{SCK}\downarrow$		C∟ = 100 pF <sup>Note</sup>	V <sub>DD</sub> = 1.8 to 5.5 V	0		1000	ns
SB0, 1↓ from SCK↑	tкsв			tксүз			ns
$\overline{SCK}\downarrow$ from SB0, 1 $\downarrow$	tsвк			tксүз			ns
SB0, 1 low-level width	t <sub>SBL</sub>			tксүз			ns
SB0, 1 high-level width	tsвн			tксүз			ns

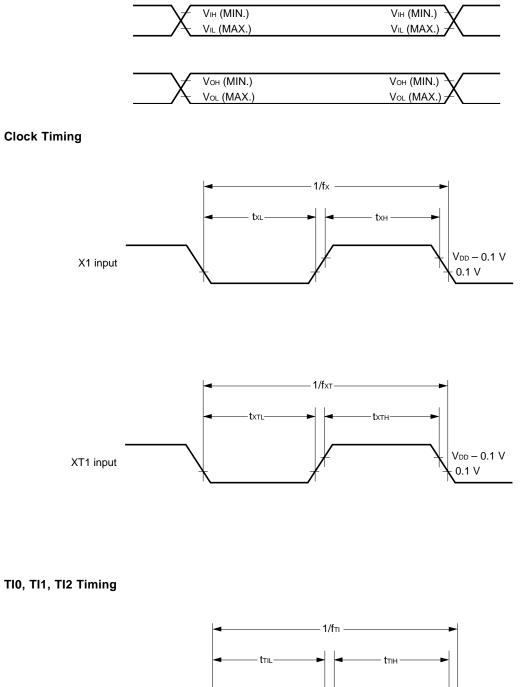
## SBI mode ( $\overline{SCK}$ ...Internal clock output (master)): (T<sub>A</sub> = -40 to +85°C, V<sub>DD</sub> = 1.8 to 5.5 V)

Note RL and CL are the load resistance and load capacitance of the SB0 and SB1 output lines, respectively.

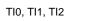
Parameter	Symbol	Test Cor	nditions	MIN.	TYP.	MAX.	Unit
SCK cycle time	<b>t</b> ксү4	V <sub>DD</sub> = 2.7 to 5.5 V	V <sub>DD</sub> = 2.7 to 5.5 V				ns
		V <sub>DD</sub> = 1.8 to 5.5 V	VDD = 1.8 to 5.5 V				ns
SCK high-/low-level	tĸ∟4, tĸн4	V <sub>DD</sub> = 2.7 to 5.5 V		400			ns
width		V <sub>DD</sub> = 1.8 to 5.5 V		1600			ns
SB0, 1 setup time	tsik4	V <sub>DD</sub> = 2.7 to 5.5 V	V <sub>DD</sub> = 2.7 to 5.5 V				ns
(to SCK↑)		V <sub>DD</sub> = 1.8 to 5.5 V		150			ns
SB0, 1 hold time (from $\overline{SCK}$ )	tksi4			tксү4/2			ns
SB0, 1 output delay	tĸso4	R∟ = 1 kΩ,	VDD = 2.7 to 5.5 V	0		300	ns
time from $\overline{SCK}\downarrow$		C∟ = 100 pF <sup>Note</sup>	VDD = 1.8 to 5.5 V	0		1000	ns
SB0, 1↓ from SCK↑	tкsв			tkCY4			ns
$\overline{\text{SCK}}\downarrow$ from SB0, 1 $\downarrow$	tsвк			tkcy4			ns
SB0, 1 low-level width	tsвl			tkCY4			ns
SB0, 1 high-level width	tsвн			tkcy4			ns

Note RL and CL are the load resistance and load capacitance of the SB0 and SB1 output lines, respectively.

# AC Timing Test Points (Excluding X1, XT1 Input)

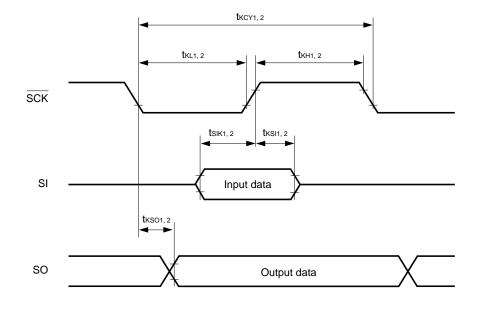


TIO, TI1, TI2 Timing

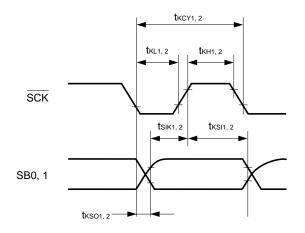


### Serial Transfer Timing

# 3-wire serial I/O mode

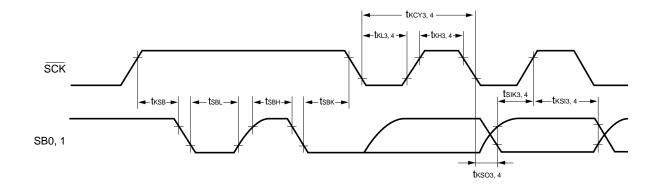


### 2-wire serial I/O mode

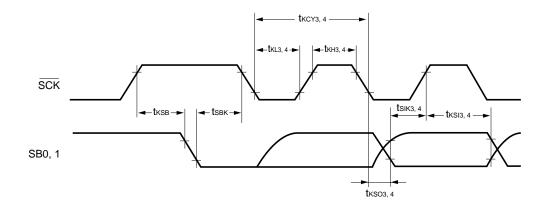


# Serial Transfer Timing

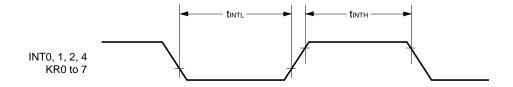
# Bus release signal transfer



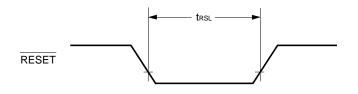
## Command signal transfer



# Interrupt input timing



# **RESET** input timing



# Data Memory Stop Mode Low Supply Voltage Data Retention Characteristics (T<sub>A</sub> = -40 to +85°C)

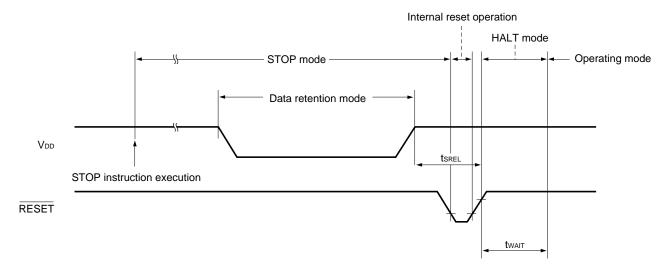
Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Release signal set time	tsrel		0			μs
Oscillation stabilization	twait	Release by RESET		215/fx		ms
wait time <sup>Note 1</sup>		Release by interrupt request		Note 2		ms

**Notes 1.** The oscillation stabilization wait time is the time during which the CPU operation is stopped to prevent unstable operation at the start of oscillation.

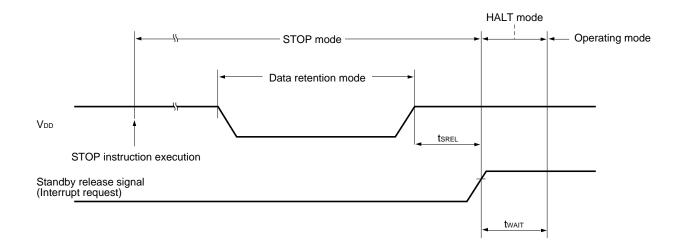
2. Depends on the basic interval timer mode register (BTM) settings (see the table below).

BTM3	BTM2	BTM1	BTM0	Wait Time			
				fx = 4.19 MHz	fx = 6.0 MHz		
—	0	0	0	2 <sup>20</sup> /fx (approx. 250 ms)	2 <sup>20</sup> /fx (approx. 175 ms)		
—	0	1	1	217/fx (approx. 31.3 ms)	2 <sup>17</sup> /fx (approx. 21.8 ms)		
—	1	0	1	2 <sup>15</sup> /fx (approx. 7.81 ms)	2 <sup>15</sup> /fx (approx. 5.46 ms)		
—	1	1	1	2 <sup>13</sup> /fx (approx. 1.95 ms)	2 <sup>13</sup> /fx (approx. 1.37 ms)		

# Data Retention Timing (STOP Mode Release by RESET)



## Data Retention Timing (Standby Release Signal: STOP Mode Release by Interrupt Signal)



Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Input voltage, high	VIH1	Except X1 and X2 pins	0.7Vdd		Vdd	V
	VIH2	X1, X2	V <sub>DD</sub> - 0.5		Vdd	V
Input voltage, low	VIL1	Except X1 and X2 pins	0		0.3Vdd	V
	VIL2	X1, X2	0		0.4	V
Input leakage current	lu -	VIN = VIL OF VIH			10	μA
Output voltage, high	Vон	Іон = -1 mA	Vdd - 1.0			V
Output voltage, low	Vol	lo∟ = 1.6 mA			0.4	V
VDD power supply current	ldd				30	mA
VPP power supply current	PP	MD0 = VIL, MD1 = VIH			30	mA

# DC Programming Characteristics (TA = 25 $\pm$ 5°C, V<sub>DD</sub> = 6.0 $\pm$ 0.25 V, V<sub>PP</sub> = 12.5 $\pm$ 0.3 V, V<sub>SS</sub> = 0 V)

Cautions 1. Do not exceed +13.5 V for VPP, including the overshoot.

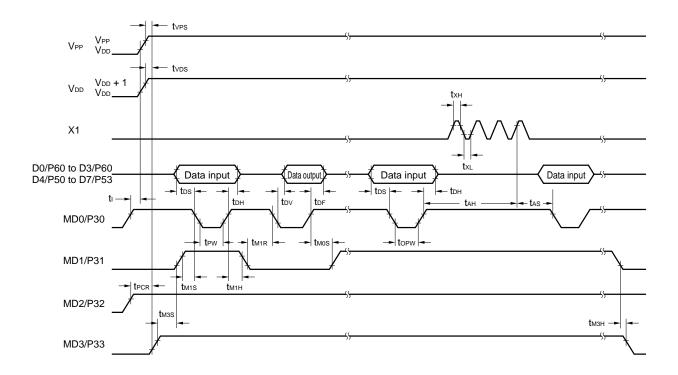
2. VDD must be applied before VPP, and cut after VPP.

### \* AC Programming Characteristics (TA = 25 $\pm$ 5°C, VDD = 6.0 $\pm$ 0.25 V, VPP = 12.5 $\pm$ 0.3 V, Vss = 0 V)

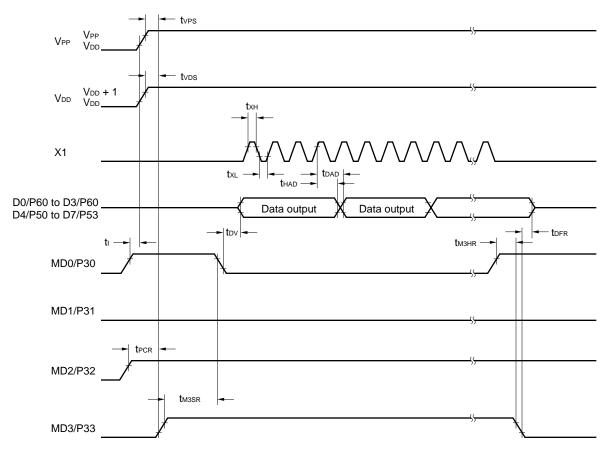
Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Address setup time <sup>Note</sup> (to MD0 $\downarrow$ )	tas		2			μs
MD1 setup time (to MD0↓)	t <sub>M1S</sub>		2			μs
Data setup time (to MD0↓)	tos		2			μs
Address hold time <sup>Note</sup> (from MD0↑)	tан		2			μs
Data hold time (from MD0 <sup>↑</sup> )	tон		2			μs
Data output float delay time from MD01	t DF		0		130	ns
V <sub>PP</sub> setup time (to MD3↑)	tvps		2			μs
V <sub>DD</sub> setup time (to MD3↑)	tvbs		2			μs
Initial program pulse width	tew		0.95	1.0	1.05	ms
Additional program pulse width	topw		0.95		21.0	ms
MD0 setup time (to MD1↑)	tмos		2			μs
Data output delay time from MD0 $\downarrow$	tov	MD0 = MD1 = VIL			1	μs
MD1 hold time (from MD0 <sup>↑</sup> )	tм1н	tм1н + tм1к ≥ 50 μs	2			μs
MD1 recovery time (from MD0 $\downarrow$ )	t <sub>M1R</sub>	-	2			μs
Program counter reset time	<b>t</b> PCR		10			μs
X1 input high-/low-level width	txн, tx∟		0.125			μs
X1 input frequency	fx				4.19	MHz
Initial mode set time	tı		2			μs
MD3 setup time (to MD1 <sup>↑</sup> )	tмзs		2			μs
MD3 hold time (from MD1↓)	tмзн		2			μs
MD3 setup time (to MD0 $\downarrow$ )	tмзsr	During program memory read	2			μs
Data output delay time from Address <sup>Note</sup>	tdad	During program memory read			2	μs
Data output hold time from Address <sup>Note</sup>	thad	During program memory read	0		130	ns
MD3 hold time (from MD0 <sup>↑</sup> )	tмзнк	During program memory read	2			μs
Data output float delay time from MD3 \downarrow $\!$	<b>t</b> dfr	During program memory read			2	μs

**Note** The internal address signal is incremented by 1 at the rising edge of the fourth X1 input and is not connected to a pin.

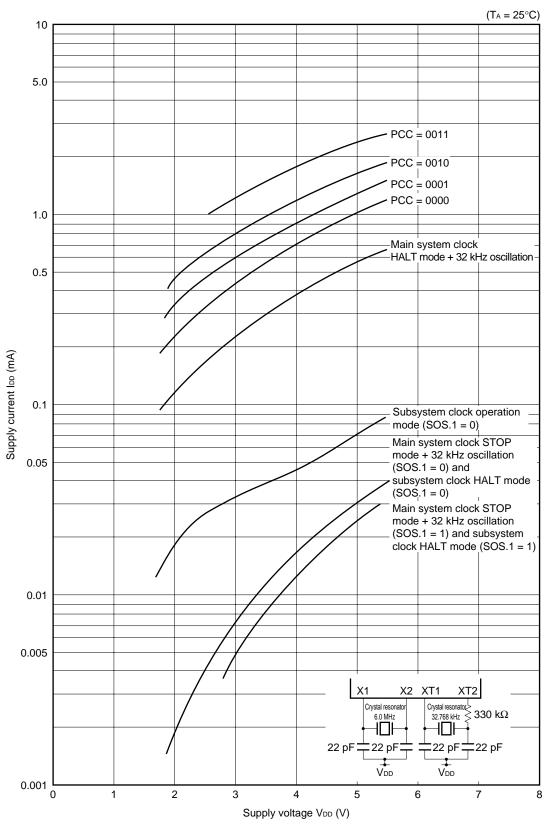
# **Program Memory Write Timing**



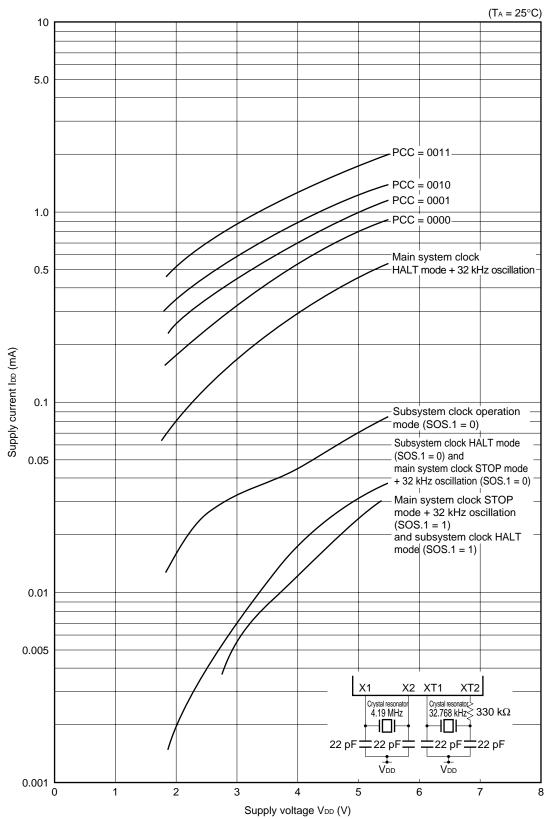
# **Program Memory Read Timing**



# **10. CHARACTERISTIC CURVES (REFERENCE VALUES)**



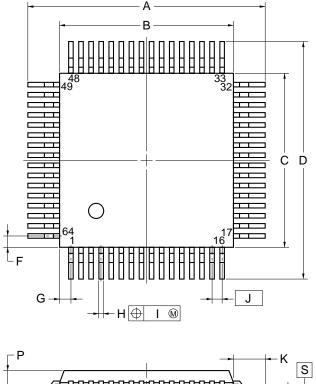
IDD VS VDD (Main System Clock: 6.0 MHz Crystal Resonator)

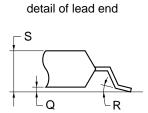


IDD VS VDD (Main System Clock: 4.19 MHz Crystal Resonator)

**11. PACKAGE DRAWINGS** 

# \* 64-PIN PLASTIC QFP (14x14)





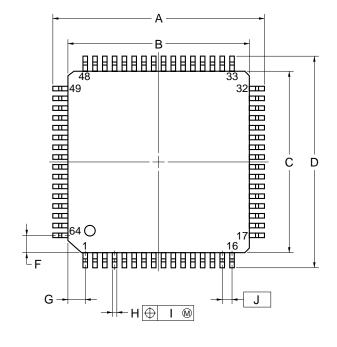
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М	

### NOTE

Each lead centerline is located within 0.15 mm of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS
А	17.6±0.4
В	14.0±0.2
С	14.0±0.2
D	17.6±0.4
F	1.0
G	1.0
н	0.37 <sup>+0.08</sup> -0.07
I	0.15
J	0.8 (T.P.)
К	1.8±0.2
L	0.8±0.2
М	0.17 <mark>+0.08</mark> -0.07
Ν	0.10
Р	2.55±0.1
Q	0.1±0.1
R	5°±5°
S	2.85 MAX.
	P64GC-80-AB8-5

# \* 64-PIN PLASTIC LQFP (12x12)



Κ

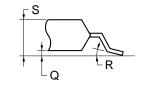
нп

L-

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ГМ

detail of lead end





# NOTE

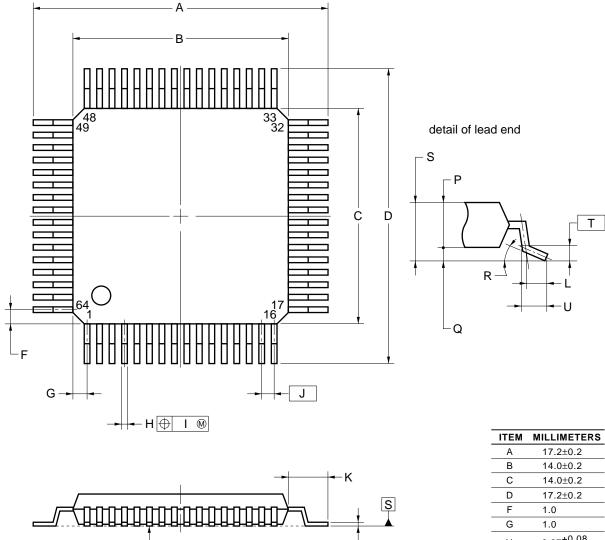
Each lead centerline is located within 0.13 mm of its true position (T.P.) at maximum material condition.

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ITEM	MILLIMETERS
А	14.8±0.4
В	12.0±0.2
С	12.0±0.2
D	14.8±0.4
F	1.125
G	1.125
Н	0.32±0.08
I	0.13
J	0.65 (T.P.)
К	1.4±0.2
L	0.6±0.2
М	0.17 <mark>+0.08</mark> -0.07
N	0.10
Р	1.4±0.1
Q	0.125±0.075
R	5°±5°
S	1.7 MAX.
	P64GK-65-8A8-3

\*

# 64-PIN PLASTIC LQFP (14x14)



М -

#### NOTE

Each lead centerline is located within 0.20 mm of its true position (T.P.) at maximum material condition.

А	17.2±0.2
В	14.0±0.2
С	14.0±0.2
D	17.2±0.2
F	1.0
G	1.0
н	0.37 <mark>+0.08</mark> -0.07
I	0.20
J	0.8 (T.P.)
К	1.6±0.2
L	0.8
М	0.17 <sup>+0.03</sup> -0.06
Ν	0.10
Р	1.4±0.1
Q	0.127±0.075
R	3° +4° -3°
S	1.7 MAX.
Т	0.25
U	0.886±0.15
	P64GC-80-8BS

# **12. RECOMMENDED SOLDERING CONDITIONS**

The  $\mu$ PD75P3116 should be soldered and mounted under the conditions recommended in the table below. For details of recommended soldering conditions, refer to the information document **Semiconductor Device Mounting Technology Manual (C10535E).** 

For soldering methods and conditions other than those recommended below, contact an NEC Sales representative.

### Table 12-1. Surface Mounting Type Soldering Conditions (1/2)

#### (1) $\mu$ PD75P3116GC-AB8: 64-pin plastic QFP (14 × 14)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Package peak temperature: 235°C, Time: 30 seconds max. (at 210°C or higher), Count: Three times or less	IR35-00-3
VPS	Package peak temperature: 215°C, Time: 40 seconds max. (at 200°C or higher), Count: Three times or less	VP15-00-3
Wave soldering	Solder bath temperature: 260°C max., Time: 10 seconds max., Count: Once, Preheating temperature: 120°C max. (package surface temperature)	WS60-00-1
Partial heating	Pin temperature: 300°C max., Time: 3 seconds max. (per pin row)	_

### Caution Do not use different soldering methods together (except for partial heating).

## (2) $\mu$ PD75P3116GK-8A8: 64-pin plastic LQFP (12 × 12)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Package peak temperature: 235°C, Time: 30 seconds max. (at 210°C or higher), Count: Twice or less Exposure limit: 7 days <sup>Note</sup> (after that, prebake at 125°C for 10 hours)	IR35-107-2
VPS	Package peak temperature: 215°C, Time: 40 seconds max. (at 200°C or higher), Count: Twice or less Exposure limit: 7 days <sup>Note</sup> (after that, prebake at 125°C for 10 hours)	VP15-107-2
Wave soldering	Solder bath temperature: 260°C max., Time: 10 seconds max., Count: Once, Preheating temperature: 120°C max. (package surface temperature) Exposure limit: 7 days <sup>Note</sup> (after that, prebake at 125°C for 10 hours)	WS 60-107-1
Partial heating	Pin temperature: 300°C max., Time: 3 seconds max. (per pin row)	_

Note After opening the dry pack, store it at 25°C or less and 65% RH or less for the allowable storage period.

#### Caution Do not use different soldering methods together (except for partial heating).

\*

# Table 12-1. Surface Mounting Type Soldering Conditions (2/2)

## (3) $\mu$ PD75P3116GC-8BS: 64-pin plastic LQFP (14 × 14)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Package peak temperature: 235°C, Time: 30 seconds max. (at 210°C or higher), Count: Twice or less	IR35-00-2
VPS	Package peak temperature: 215°C, Time: 40 seconds max. (at 200°C or higher), Count: Twice or less	VP15-00-2
Wave soldering	Solder bath temperature: 260°C max., Time: 10 seconds max., Count: Once, Preheating temperature: 120°C max. (package surface temperature)	WS60-00-1
Partial heating	Pin temperature: 300°C max., Time: 3 seconds max. (per pin row)	_

Caution Do not use different soldering methods together (except for partial heating).

# APPENDIX A. LIST OF $\mu \text{PD75308B},$ 753108, AND 75P3116 FUNCTIONS

	Parameter	μPD75308B	μPD753108	μPD75P3116	
Program men	nory	Mask ROM 0000H to 1F7FH (8064 × 8 bits)	Mask ROM 0000H to 1FFFH (8192 × 8 bits)	One-time PROM 0000H to 3FFFH (16384 × 8 bits)	
Data memory			000H to 1FFH (512 × 4 bits)		
CPU		75X Standard	75XL CPU		
Instruction execution	When main system clock is selected	0.95, 1.91, 15.3 μs (during 4.19 MHz operation)	<ul> <li>0.95, 1.91, 3.81, 15.3 μs (α</li> <li>0.67, 1.33, 2.67, 10.7 μs (α</li> </ul>		
time	When subsystem clock is selected	122 $\mu$ s (during 32.768 kHz c	peration)		
Stack	SBS register	None	SBS.3 = 1: Mk I mode select SBS.3 = 0: Mk II mode select		
	Stack area	000H to 0FFH	000H to 1FFH		
	Subroutine call instruc- tion stack operation	2-byte stack	When Mk I mode: 2-byte s When Mk II mode: 3-byte s		
Instruction	BRA !addr1 CALLA !addr1	Unavailable	When Mk I mode: Unavailable When Mk II mode: Available		
	MOVT XA, @BCDE MOVT XA, @BCXA BR BCDE BR BCXA		Available		
	CALL !addr	3 machine cycles	Mk I mode: 3 machine cycles Mk II mode: 4 machine cycles		
	CALLF !faddr	2 machine cycles	Mk I mode: 2 machine cycles Mk II mode: 3 machine cycles		
I/O ports	CMOS input	8	8		
	CMOS I/O	16	20		
	Bit port output	8	0		
	N-ch open-drain I/O	8	4		
	Total	40	32		
LCD controlle	r/driver	Segment selection: 24/28/32 (can be changed to CMOS I/O port in 4-bit units; max. 8)	Segment selection: 16/20/24 segments (can be changed to CMOS I/O port in 4-bit units; max. 8		
Timer		Display mode selection: Static, 1/2 duty (1/2 bias), 1/3 duty (1/2 bias), 1/3 duty (1/2 bias), 1/3 duty (1/3 bias)		ty (1/2 bias), 1/3 duty	
		On-chip split resistor for LCE using mask option.	D driver can be specified by	No on-chip split resistor for LCD driver	
		<ul> <li>3 channels</li> <li>Basic interval timer: <ol> <li>channel</li> <li>8-bit timer/event counter: <ol> <li>channel</li> <li>Watch timer: 1 channel</li> </ol> </li> </ol></li></ul>	<ul> <li>5 channels</li> <li>Basic interval timer/watchdog timer: 1 channel</li> <li>8-bit timer/event counter: 3 channels (can be used as 16-bit timer/event counter)</li> <li>Watch timer: 1 channel</li> </ul>		

F	Parameter	μPD75308B	μPD753108	μPD75P3116	
Clock output (P	CL)	Φ, 524, 262, 65.5 kHz (Main system clock: during 4.19 MHz operation)	<ul> <li>Φ, 524, 262, 65.5 kHz (Main system clock: during 4.19 MHz operation)</li> <li>Φ, 750, 375, 93.8 kHz (Main system clock: during 6.0 MHz operation)</li> </ul>		
BUZ output (BL	IZ)	2 kHz (Main system clock: during 4.19 MHz operation)	<ul> <li>2, 4, 32 kHz (Main system clock: during 4.19 MHz operation or subsystem clock: during 32.768 kHz operation)</li> <li>2.93, 5.86, 46.9 kHz (Main system clock: during 6.0 MHz operation)</li> </ul>		
Serial interface		3 modes are available • 3-wire serial I/O mode MSB/LSB can be selected for transfer first bit • 2-wire serial I/O mode • SBI mode			
SOS register	Feedback resistor cut flag (SOS.0)				
	Sub-oscillator current cut flag (SOS.1)	None	Contained		
Register bank s	election register (RBS)	None	Yes		
Standby release	e by INT0	No	Yes		
Vectored interru	ipts	External: 3, Internal: 3	External: 3, Internal: 5		
Supply voltage		V <sub>DD</sub> = 2.0 to 6.0 V	V <sub>DD</sub> = 1.8 to 5.5 V		
Operating ambi	ent temperature	$T_{A} = -40 \text{ to } +85^{\circ}\text{C}$			
Package		<ul> <li>80-pin plastic QFP (14 × 20)</li> <li>80-pin plastic QFP (14 × 14)</li> <li>80-pin plastic TQFP (Fine pitch) (12 × 12)</li> </ul>	<ul> <li>64-pin plastic QFP (14 × 14)</li> <li>64-pin plastic LQFP (12 × 12)</li> <li>64-pin plastic TQFP (12 × 12)</li> <li>64-pin plastic LQFP (14 × 14)</li> </ul>	<ul> <li>64-pin plastic QFP (14 × 14)</li> <li>64-pin plastic LQFP (12 × 12)</li> <li>64-pin plastic LQFP (14 × 14)</li> </ul>	

# APPENDIX B. DEVELOPMENT TOOLS

The following development tools have been provided for system development using the  $\mu$ PD75P3116. In the 75XL Series, a common relocatable assembler is used in combination with a device file dedicated to each model.

*	RA75X relocatable assembler	Host Machine	Part Number		
			OS	Supply Medium	(Product Name)
		PC-9800 Series	MS-DOS™	3.5" 2HD	μS5A13RA75X
			$\left( \begin{array}{c} \text{Ver.3.30 to} \\ \text{Ver.6.2}^{\text{Note}} \end{array} \right)$		
		IBM PC/AT™ or compatibles	Refer to OS for IBM PCs	3.5" 2HC	μS7B13RA75X

*	Device file	Host Machine	Part Number		
			OS	Supply Medium	(Product Name)
		PC-9800 Series	MS-DOS	3.5" 2HD	μS5A13DF753108
			$\left( \begin{array}{c} \text{Ver.3.30 to} \\ \text{Ver.6.2}^{\text{Note}} \end{array}  ight)$		
		IBM PC/AT or compatibles	Refer to OS for IBM PCs	3.5" 2HC	μS7B13DF753108

**Note** Ver. 5.00 and later include a task swapping function, but this function cannot be used in this software.

**Remark** Operation of the assembler and device file is guaranteed only when using the host machine and OS described above.

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# **PROM Write Tools**

Hardware	PG-1500	mode or under the cor and optional program	This is a PROM writer that can program a single-chip microcontroller with PROM in stand-alone mode or under the control of a host machine when connected with the supplied accessory board and optional programmer adapter. It can also program typical PROMs in capacities ranging from 256 Kb to 4 Mb.				
	PA-75P3116GC		This is a PROM programmer adapter for the $\mu$ PD75P3116GC-AB8. t can be used when connected to the PG-1500.				
	PA-75P3116GK		his is a PROM programmer adapter for the $\mu$ PD75P3116GK-8A8. can be used when connected to the PG-1500.				
	PA-75P3116GC-8BS		This is a PROM programmer adapter for the $\mu$ PD75P3116GC-8BS. t can be used when connected to the PG-1500.				
Software	PG-1500 controller	Connects the PG-1500 to the host machine via serial and parallel interfaces and controls PG-1500 on the host machine.					
		Host machine			Part number		
			OS	Supply medium	(Product name)		
		PC-9800 Series	MS-DOS (Ver.3.30 to Ver.6.2 <sup>Note</sup> )	3.5" 2HD	μS5A13PG1500		
		IBM PC/AT or compatible	Refer to OS for IBM PCs	3.5" 2HD	μS7B13PG1500		

Note Ver. 5.00 and later include a task swapping function, but this function cannot be used in this software.

**Remark** Operation of the PG-1500 controller is guaranteed only when using the host machine and OS described above.

# **Debugging Tools**

An in-circuit emulator (IE-75001-R) is provided as a program debugging tool for the  $\mu$ PD75P3116.

The system configuration using this in-circuit emulator is shown below.

*	Hardware	IE-	75001-R	The IE-75001-R is an in-circuit emulator to be used for hardware and software debugging during development of application systems using the 75X or 75XL Series products. The IE-75001-R is used in combination with an emulation board (IE-75300-R-EM) and emulation probe (EP-753108GC-R or EP-753108GK-R) (both sold separately). Highly efficient debugging can be performed when connected to the host machine and PROM programmer.				
		IE-	75300-R-EM		oard for evaluating appli on with the IE-75001-R.	cation systems using the	e μPD75P3116.	
		EP	-753108GC-R		robe for the $\mu$ PD75P311		00-B-FM	
		EV-9200GC-64			When being used, it is connected with the IE-75001-R and the IE-75300-R-EM. It includes a 64-pin conversion socket (EV-9200GC-64) to facilitate connection with the target system.			
		EP	-753108GK-R	This is an emulation probe for the $\mu$ PD75P3116GK. When being used, it is connected with the IE-75001-R and the IE-75300-R-EM.				
			TGK-064SBW Note 1	It includes a 64-pin conversion adapter (TGK-064SBW) to facilitate connection with the target system.				
	Software	ΙΕ α	control program	This program can contr via an RS-232C or Cer	ol the IE-75001-R on a henternation of the IE-75001-R on a herternation of the term of ter	ost machine when conne	cted to the IE-75001-R	
				Host machine			Part number	
					OS	Supply medium	(Product name)	
				PC-9800 Series	MS-DOS	3.5" 2HD	μS5A13IE75X	
					$\left( \begin{array}{c} \text{Ver.3.30 to} \\ \text{Ver.6.2}^{\text{Note 2}} \end{array} \right)$			
				IBM PC/AT or compatible	Refer to <b>OS for</b> IBM PCs	3.5" 2HC	μ\$7B13IE75X	

★ Notes 1. This is a product of TOKYO ELETECH CORPORATION.
 Contact: Daimaru Kogyo, Ltd. Tokyo Electronic Department (TEL: +81-3-3820-7112)

Osaka Electronic Department (TEL: +81-6-6244-6672)

- 2. Ver. 5.00 and later include a task swapping function, but this function cannot be used in this software.
- **Remarks 1.** Operation of the IE control program is guaranteed only when using the host machine and OS described above.
  - **2.** The  $\mu$ PD753104, 753106, 753108, and 75P3116 are generically called the  $\mu$ PD753108 Subseries.

# OS for IBM PCs

The following operating systems for IBM PCs are supported.

OS	Version
PC DOS™	Ver.3.1 to 6.3 J6.1/V <sup>Note</sup> to J6.3/V <sup>Note</sup>
MS-DOS	Ver.5.0 to 6.2 5.0/V <sup>Note</sup> to 6.2/V <sup>Note</sup>
IBM DOS™	J5.02/V <sup>Note</sup>

**Note** Only English mode is supported.

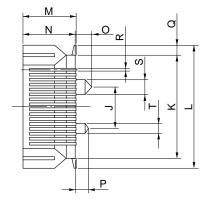
Caution Ver. 5.0 and later include a task swapping function, but this function cannot be used in this software.

\* Package Drawing and Recommended Footprint of Conversion Socket (EV-9200GC-64)

Figure B-1. EV-9200GC-64 Package Drawing (For Reference Only)

# A В Е F NEC C = EV-9200GC-( 危 No.1 pin index

G Н I



	EV-9200GC-64-G0		
ITEM	MILLIMETERS INCHES		
Α	18.8	0.74	
В	14.1	0.555	
С	14.1	0.555	
D	18.8	0.74	
Е	4-C 3.0	4-C 0.118	
F	0.8	0.031	
G	6.0	0.236	
н	15.8	0.622	
I	18.5	0.728	
J	6.0	0.236	
к	15.8	0.622	
L	18.5	0.728	
М	8.0	0.315	
N	7.8	0.307	
0	2.5	0.098	
Р	2.0	0.079	
Q	1.35	0.053	
R	0.35±0.1	$0.014^{+0.004}_{-0.005}$	
S	ø2.3	¢0.091	
Т	¢1.5	¢0.059	

# /-9200GC-64-G0E

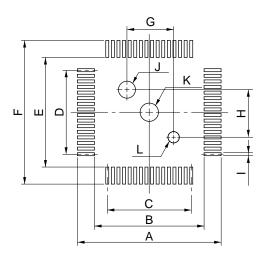


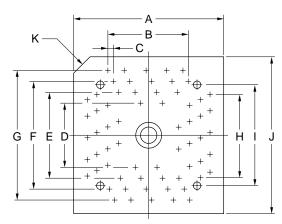
Figure B-2. EV-9200GC-64 Recommended Footprint (For Reference Only)

EV-9200GC-64-P1E

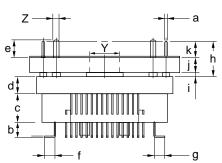
ITEM	MILLIMETERS	INCHES
A	19.5	0.768
В	14.8	0.583
С	$0.8\pm0.02 \times 15=12.0\pm0.05$	$0.031^{+0.002}_{-0.001} \times 0.591 {=} 0.472^{+0.003}_{-0.002}$
D	$0.8\pm0.02 \times 15=12.0\pm0.05$	$0.031^{+0.002}_{-0.001} \times 0.591 {=} 0.472^{+0.003}_{-0.002}$
E	14.8	0.583
F	19.5	0.768
G	6.00±0.08	$0.236^{+0.004}_{-0.003}$
Н	6.00±0.08	$0.236^{+0.004}_{-0.003}$
I	0.5±0.02	$0.197^{+0.001}_{-0.002}$
J	¢2.36±0.03	$\phi_{0.093^{+0.001}_{-0.002}}$
К	φ2.2±0.1	$\phi_{0.087^{+0.004}_{-0.005}}$
L	¢1.57±0.03	$\phi_{0.062^{+0.001}_{-0.002}}$

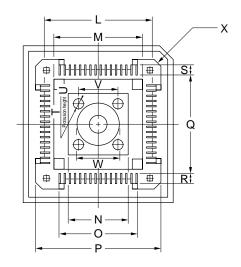
Caution Dimensions of mount pad for EV-9200 and that for target device (QFP) may be different in some parts. For the recommended mount pad dimensions for QFP, refer to "SEMICONDUCTOR DEVICE MOUNTING TECHNOLOGY MANUAL" (C10535E).

# \* Package Drawing of Conversion Adapter (TGK-064SBW)



# Figure B-3. TGK-064SBW Package Drawing (For Reference Only)





ITEM	MILLIMETERS	INCHES	ITEM	MILLIMETERS	INCHES
А	18.4	0.724	а	<i>φ</i> 0.3	<i>ф</i> 0.012
В	0.65x15=9.75	0.026x0.591=0.384	b	1.85	0.073
С	0.65	0.026	с	3.5	0.138
D	7.75	0.305	d	2.0	0.079
Е	10.15	0.400	е	3.9	0.154
F	12.55	0.494	f	1.325	0.052
G	14.95	0.589	g	1.325	0.052
н	0.65x15=9.75	0.026x0.591=0.384	h	5.9	0.232
I	11.85	0.467	i	0.8	0.031
J	18.4	0.724	j	2.4	0.094
Κ	C 2.0	C 0.079	k	2.7	0.106
L	12.45	0.490		-	TGK-064SBW-G1
М	10.25	0.404			
Ν	7.7	0.303			
0	10.02	0.394			
Р	14.92	0.587			
Q	11.1	0.437			
R	1.45	0.057			
S	1.45	0.057			
Т	4- <i>ф</i> 1.3	4- <i>ф</i> 0.051			
U	1.8	0.071			
V	5.0	0.197			
W	<i>\$</i> 5.3	<i>ф</i> 0.209			
Х	4-C 1.0	4-C 0.039			
Y	<i>\$</i> 3.55	<i>ф</i> 0.140			
Z	<i>φ</i> 0.9	<i>ф</i> 0.035			

### Notes on Target System Design

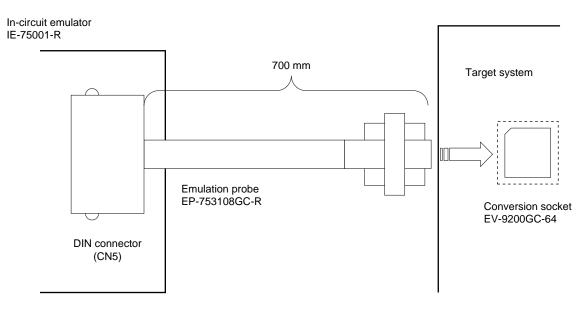
The following shows a diagram of the connection conditions between the emulation probe, conversion connector and conversion socket or conversion adapter.

Design your system making allowances for conditions such as the form of parts mounted on the target system, as shown below.

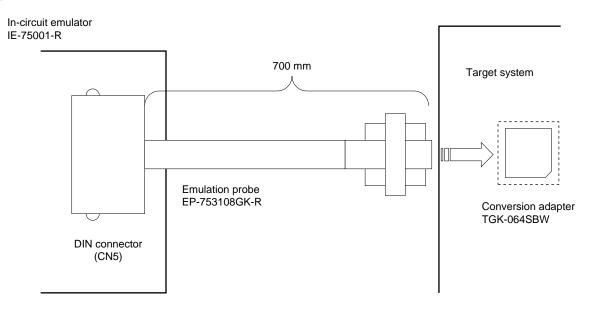
Emulation Probe	Conversion Socket/ Conversion Adapter	Distance Between In-Circuit Emulator and Conversion Socket or Conversion Adapter
EP-753108GC-R	EV-9200GC-64	700 mm
EP-753108GK-R	TGK-064SBW	700 mm

### Table B-1. Distance Between In-Circuit Emulator and Conversion Socket

#### Figure B-4. Distance Between In-Circuit Emulator and Conversion Socket or Conversion Adapter (1)



#### Figure B-5. Distance Between In-Circuit Emulator and Conversion Socket or Conversion Adapter (2)



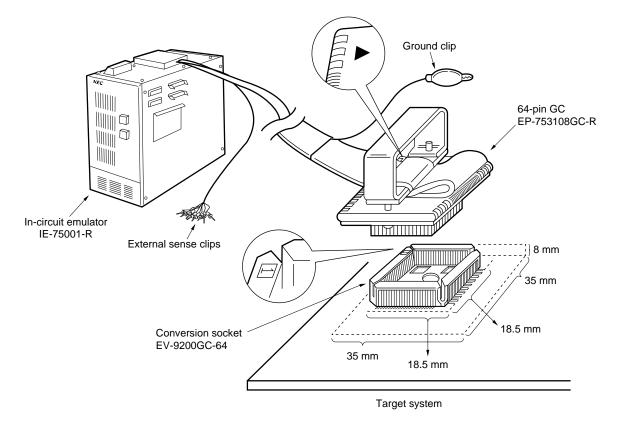
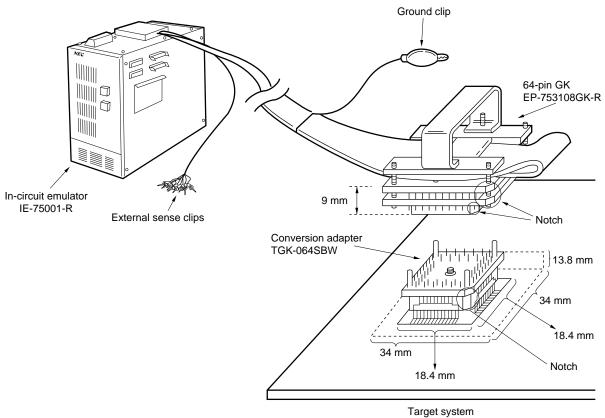


Figure B-6. Connection Conditions of Target System (1)

Figure B-7. Connection Conditions of Target System (2)



#### \*

# APPENDIX C. RELATED DOCUMENTS

The related documents indicated in this publication may include preliminary versions. However, preliminary versions are not marked as such.

## **Documents Related to Devices**

Document Name	Document No.
μPD753104, 753106, 753108 Data Sheet	U10086E
μPD75P3116 Data Sheet	This document
μPD753108 User's Manual	U10890E
75XL Series Selection Guide	U10453E

## Documents Related to Development Tools (Software) (User's Manuals)

Document Name		Document No.
RA75X Assembler Package	Operation	U12622E
	Language	U12385E
	Structured Assembler Preprocessor	U12598E

# Documents Related to Development Tools (Hardware) (User's Manuals)

Document Name	Document No.
IE-75000-R, IE-75001-R In-Circuit Emulator	EEU-1455
IE-75300-R-EM Emulation Board	U11354E
EP-753108GC-R, EP-753108GK-R Emulation Probe	EEU-1495

# Documents Related to PROM Writing (User's Manuals)

Document Name		Document No.
PG-1500 PROM Programmer		U11940E
PG-1500 Controller PC-9800 Series (MS-DOS) Based		EEU-1291
	IBM PC Series (PC DOS) Based	U10540E

Caution The related documents listed above are subject to change without notice. Be sure to use the latest version of each document for designing.

# **Other Related Documents**

Document Name	Document No.
SEMICONDUCTOR SELECTION GUIDE - Products & Packages -	X13769E
Semiconductor Device Mounting Technology Manual	C10535E
Quality Grades on NEC Semiconductor Devices	C11531E
NEC Semiconductor Device Reliability/Quality Control System	C10983E
Guide to Prevent Damage for Semiconductor Devices by Electrostatic Discharge (ESD)	C11892E

Caution The related documents listed above are subject to change without notice. Be sure to use the latest version of each document for designing.

[MEMO]

# - NOTES FOR CMOS DEVICES -

## **1** PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

#### Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

### (2) HANDLING OF UNUSED INPUT PINS FOR CMOS

#### Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

### ③ STATUS BEFORE INITIALIZATION OF MOS DEVICES

#### Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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· Device availability

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- Ordering information
- Product release schedule
- · Availability of related technical literature
- Development environment specifications (for example, specifications for third-party tools and components, host computers, power plugs, AC supply voltages, and so forth)
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